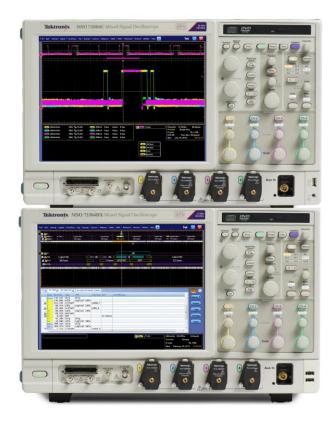
Tektronix[®]

Digital and Mixed Signal Oscilloscopes

MSO/DPO70000 Series Datasheet



Engineers rely on an oscilloscope throughout their design cycle, from prototype turn-on to production testing. The MSO/DPO70000 Series oscilloscopes' unique capabilities combined with exceptional signal acquisition performance and analysis accelerate your measurement tasks.

Key performance specifications

- Up to 33 GHz analog bandwidth and rise time as fast as 9 ps. Enables measurement on the latest high-speed serial standards
- True 33 GHz Real-time Analog Bandwidth on 2 Channels with 33 GHz models
- Industry-leading sample rate and timing resolution
 - 100 GS/s on 2 Channels (33, 25, 23, 20, 16, and 12.5 GHz models)

- Four-channel Simultaneous Performance
 - Up to 23 GHz Bandwidth
 - Up to 50 GS/s Real-time Sample Rate
 - Up to 500 Megasample Record Length with MultiView Zoom[™] for quick navigation
 - Fastest Waveform Capture Rate with >300,000 wfms/s maximum per channel
- 16 Logic Channels with 80 ps Timing Resolution for Debug of digital and analog signals (MSO70000 Series only)
- Unique iCapture® capability enables viewing analog characteristics of digital channels with single probe connection
- 6.25 Gb/s Real-time Serial Trigger Assures triggering on the first instance of a specified NRZ or 8b/10b pattern to allow isolation of pattern-dependent effects
- Application Support for High-speed Serial Industry Standards. wideband RF, Power supplies, and memory - Enables standardspecific certification, measurement automation, and ease of use

Key features

- Superior signal integrity and excellent signal-to-noise ratio observe the truest representation of your waveform
- Pinpoint® triggering minimize time spent trying to acquire problem signals for efficient troubleshooting and shortened debug time
- Visual Trigger precisely qualify triggers and find unique events in complex waveforms
- Search and Mark provides waveform or serial bus pattern matching and software triggers for signals of interest
- Automated Serial Analysis options for PCI Express, 8b/10b encoded serial data, I²C, SPI, CAN, LIN, FlexRay, RS-232/422/485/UART, USB 2.0, HSIC, MIL-STD-1553B, and MIPI® C-PHY, D-PHY and M-PHY
- P7600 and P7500 TriMode[™] probing system perfectly matched signal connectivity
- P6780, P6750, and P6717A high-performance 17-channel logic probes with bandwidths up to 2.5 GHz for connections to today's fast digital signals (MSO70000 Series only)

Connectivity

- USB 2.0 host port on both the front panel and rear panel for quick and easy data storage, printing, and connecting a USB keyboard
- Integrated 10/100 Ethernet port for network connection and Video Out port to export the oscilloscope display to a monitor or projector

Quick selection guide

Model	Analog Bandwidth	Analog Sample Rate – 2/4 Channels	Standard Memory – Analog + Digital	Analog Channels	Logic Channels
DPO70404C	4 GHz	25 GS/s	31 MS	4	_
MSO70404C	4 GHz	25 GS/s	62 MS	4	16
DPO70604C	6 GHz	25 GS/s	31 MS	4	_
MSO70604C	6 GHz	25 GS/s	62 MS	4	16
DPO70804C	8 GHz	25 GS/s	31 MS	4	_
MSO70804C	8 GHz	25 GS/s	62 MS	4	16
DPO71254C	12.5 GHz	100 GS/s / 50 GS/s	31 MS	4	_
MSO71254C	12.5 GHz	100 GS/s / 50 GS/s	62 MS	4	16
DPO71604C	16 GHz	100 GS/s / 50 GS/s	31 MS	4	_
MSO71604C	16 GHz	100 GS/s / 50 GS/s	62 MS	4	16
DPO72004C	20 GHz	100 GS/s / 50 GS/s	31 MS	4	_
MSO72004C	20 GHz	100 GS/s / 50 GS/s	62 MS	4	16
DPO72304DX	23 GHz	100 GS/s / 50 GS/s	31 MS	4	_
MSO72304DX	23 GHz	100 GS/s / 50 GS/s	62 MS	4	16
DPO72504DX	25 GHz	100 GS/s / 50 GS/s	31 MS	4	_
MSO72504DX	25 GHz	100 GS/s / 50 GS/s	62 MS	4	16
DPO73304DX	33 GHz	100 GS/s / 50 GS/s	31 MS	4	_
MSO73304DX	33 GHz	100 GS/s / 50 GS/s	62 MS	4	16

Application support

- High-speed serial industry standards compliance
- SignalVu® RF and vector signal analysis
- DDR memory bus analysis

Applications

- Design verification including signal integrity, jitter, and timing analysis
- Design characterization for high-speed, sophisticated designs
- Certification testing of serial data streams for industry standards
- Memory bus analysis and debug
- Prototype turn-on and power supply verification
- Research and investigation of transient phenomena
- Production testing of complex systems
- Spectral analysis of transient or wide-bandwidth RF signals

System turn-on and verification

From the time a design is first powered up through the initial operational checks, the MSO/DPO70000 Series provide the features you need.

Uncompromised four-channel acquisition

With very low noise and up to 50 GS/s sample rate on all four channels the DPO70000 Series ensures that signal integrity checks and timing analysis can be done without worrying about noise and jitter in the scope distorting the measurements. Single-shot bandwidths up to 23 GHz on all four channels ensure that you'll capture your signals of interest without worrying about undersampling when using more than 1 or 2 channels.

For applications requiring the lowest internal noise and jitter, 100 GS/s performance further reduces noise and jitter and provides additional measurement headroom.

Unmatched acquisition and signal-to-noise performance

The superior signal integrity and excellent signal-to-noise ratio of the MSO/ DPO70000 Series ensures confidence in your measurement results.

- Up to 33 GHz, matched across 4 channels
- Bandwidth enhancement eliminates imperfections in frequency response all the way to the probe tip. User-selectable filters for each channel provide magnitude and phase correction for more accurate representation of extremely fast signals. In addition, only Tektronix allows the user to disable the bandwidth enhancement for applications needing the highest measurement throughput.
- Simultaneous high sample rate on all channels captures more signal details (transients, imperfections, fast edges)
 - 100 GS/s on 2 channels and 50 GS/s on all analog channels for the 12.5 through 33 GHz models
 - 25 GS/s on all analog channels for the 4, 6, and 8 GHz models
 - 12.5 GS/s on all logic channels in the MSO70000 Series
- Low jitter noise floor and high vertical accuracy provide additional margin in your measurements
- Long record length provides high resolution and extended-duration waveform capture
 - Standard 31 MS per channel on the DPO70000 Series and 62 MS on the MSO70000 Series
 - Optional up to 125 MS on all four channels (4, 6, and 8 GHz models) and 250 MS (12.5 through 20 GHz models) on all four channels; up to 500 MS on four channels/1 GS on two channels for 23, 25, and 33 GHz models.
 - On the MSO70000 Series, the record length of logic channels matches the analog record lengths for uncompromised analog and digital acquisition
 - MultiView Zoom helps you manage long records, compare and analyze multiple waveform segments
- With high signal-to-noise ratio and low internal noise floor, the MSO/ DPO70000 Series enable you to perform precise characterization measurements. When debugging a DUT, a low noise floor and maximum signal fidelity of the measurement instrument allows you to find the smallest anomalies affecting the DUT's performance. For RF signals, a lower noise floor translates into a higher dynamic range, opening the MSO/DPO70000 Series to a wider range of applications.

Widest range of probing solutions

Whether you need to measure 8 Gb/s serial data, fast digital logic, or switching currents from your new power supply design, Tektronix offers a vast array of probing solutions, including active single-ended, differential, logic, high voltage, current, optical, and a wide range of probe and oscilloscope accessories.



P7633 Low Noise TriMode probes simplify complex measurement setups.



P6780 Differential Logic probes provide high-bandwidth connections for up to 16 digital signals.

16-channel digital acquisition (MSO70000 Series)

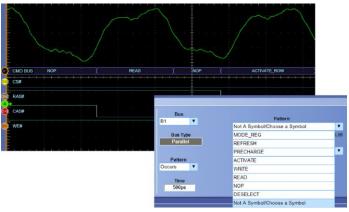
When you have many interfaces to verify, the MSO70000 Series with 4 analog and 16 logic channels enables efficient channel-to-channel timing checks. With timing resolution of 80 ps, the MSO70000 Series' digital acquisition system enables you to make precise timing measurements on as many as 20 channels simultaneously.

iCapture[™] - One connection for analog and digital (MSO70000 Series)

The number of signals that must be verified can often make the checkout of a design long and involved. By using the iCapture[™] digital-to-analog multiplexer feature, you can easily verify the analog characteristics of any of the 16 signals connected to the MSO70000 Series' digital channels without changing probes or connections. Using iCapture[™], you can quickly view the analog characteristics of any input channel. If the signal is working as expected, relegate it to a digital-only view and continue testing other lines.

Bus decoding and triggering

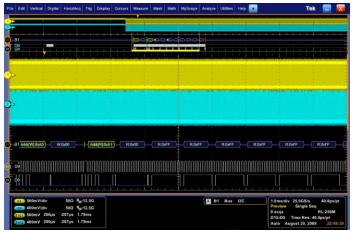
Verifying your system operation often requires the ability to see specific system states on a key bus such as the DDR SDRAM interface. The MSO/ DPO70000 Series includes parallel and serial bus decoding that provides deeper insight into the system's behavior. Using the bus triggering capability of the MSO/DPO70000 Series to isolate the exact state needed or find invalid bus sequences is as easy as defining the bus and choosing the bit pattern or symbolic word that describes the desired state. In addition, serial bus decoding for 8b/10b encoded data, I²C, SPI, RS-232/422/485/UART, USB, and MIPI® DSI and CSI2 buses enables you to identify where control and data packets begin and end as well as identify subpacket components such as address, data, CRC, etc.



Symbolic bus formats simplify identifying system states and setting up bus triggers.

Deep record length available on all channels

Longer duration events such as power supply sequencing and system status words can be analyzed without sacrificing timing resolution using the long memory depths available on all four analog channels in the DPO70000 Series as well as the 16 logic channels of the MSO70000 Series. Optional memory depths up to 125 MS (Option 10XL) on the 4, 6, and 8 GHz models, 250 MS (Option 20XL) on the 12.5 through 20 GHz models and 500 MS (4 channels)/1 GS (2 channels) with option 50XL on the 23 through 33 GHz models are available.



10 ms duration capture of synchronous high-speed and low-speed signals at 25 GS/s.

Power supplies can be a critical failure point in any system. Careful testing of the power delivery system's power on sequence can be time consuming. The MSO70000 Series provides independent logic thresholds for each logic channel enabling multiple logic voltages to be set up and observed simultaneously for quick verification of the system's power rails.

Protocol and serial pattern triggering

To verify serial architectures, the serial pattern triggering for NRZ serial data streams with built-in clock recovery in the MSO/DPO70000 Series allows correlating events across physical and link layers. The instruments can recover the clock signal, identify transitions, and allow you to set the desired encoded words for the serial pattern trigger to capture. This feature comes standard on the MSO70000 Series and is available on the DPO70000 Series as Option ST6G. For higher bit rate standards like USB 3.0, the 8b/10b serial pattern trigger and decode covers data rates up to 6.25 Gb/s.

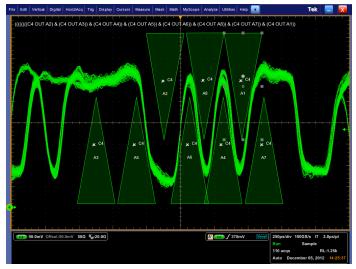
Pattern lock triggering adds an extra dimension to NRZ serial pattern triggering by enabling the oscilloscope to take synchronized acquisitions of a long serial test pattern with outstanding time base accuracy. Pattern lock triggering can be used to remove random jitter from long serial data patterns. Effects of specific bit transitions can be investigated, and averaging can be used with mask testing. Pattern lock triggering supports up to 6.25 Gb/s NRZ serial data streams and is standard on the MSO70000 Series instruments, or is included as part of Option ST6G on the DPO70000 Series.

Visual Trigger - Find the signal of interest quickly

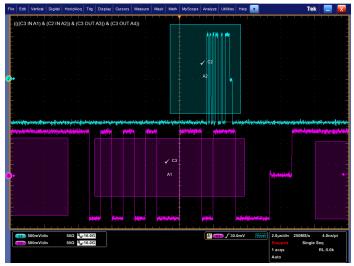
Finding the right cycle of a complex bus can require hours of collecting and sorting through thousands of acquisitions for an event of interest. Defining a trigger that isolates the desired event speeds up debug and analysis efforts.

Visual Trigger qualifies the Tektronix Pinpoint Triggers by scanning through all waveform acquisitions and comparing them to on-screen areas (geometric shapes). Up to eight areas can be created using a mouse or touchscreen, and a variety of shapes (triangles, rectangles, hexagons, or trapezoids) can be used to specify the desired trigger behavior. Once shapes are created, they can be edited interactively to create ideal trigger conditions

Visual Trigger extends the Tektronix oscilloscope's triggering capabilities for a wide variety of complex signals as illustrated by the examples shown here.



Customized serial triggering. Visual Trigger set to find a serial data pattern of 1101 0101.



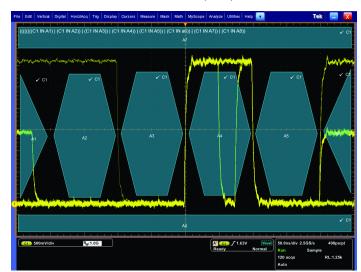
Multiple channel triggering. Visual Trigger areas can be associated with events spanning multiple channels such as packets transmitted on two USB2.0 buses simultaneously.

By triggering only on the most important signal events, Visual Trigger can save hours of capturing and manually searching through acquisitions. In seconds or minutes, you can find the critical events and complete your debug and analysis efforts. Using the Mark All Trigger Events feature, once your Visual Trigger is set, your oscilloscope can automatically search the entire acquired waveform for all events with the same characteristics and mark them for you - a great time-saving feature.

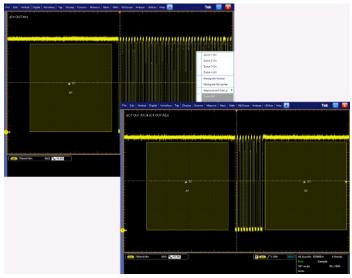
DDR memory bus events involve clocks, strobes and data channels as well as multiple amplitudes and bursts of data.



DDR memory. Visual Trigger used to isolate a rare occurrence of a write burst on a specific bit pattern in DDR3. The trigger event is a Write DQ burst of 11000000, when the DQ launch starts from a non-tri-state voltage value. DDR memory bus events involve clocks, strobes and data channels as well as multiple amplitudes and bursts of data.



Boolean logic trigger qualification. Boolean logic using logical OR allows the user to simultaneously monitor each bit and capture the occurrence of an anomaly at any point in the acquisition.



Trigger on the width of a burst of 10 pulses. By drawing a "Must be outside" area before the first clock pulse and a second "Must be outside" area after the tenth pulse, as shown, you can define a Visual Trigger setup that captures the desired burst width.

System characterization and margin testing

When a design is working correctly and the next task is to fully characterize its performance, the MSO/DPO70000 Series offers the industry's most comprehensive set of analysis and certification tools, such as math expressions, waveform mask testing, pass/fail testing, event searching, and event marking. Tools for automation reduce the tedium, increase reliability, and speed up the process of making hundreds of characterization measurements.

Advanced waveform analysis

Full analysis of the power, voltage, and temperature corners of your system under test can be very time consuming. The MSO/DPO70000 Series offer a wide range of built-in advanced waveform analysis tools.

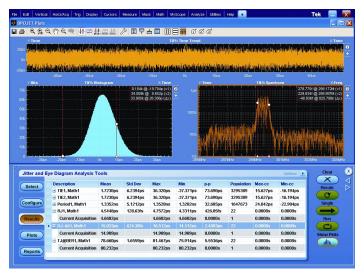
Waveform cursors make it easy to measure trace-to-trace timing characteristics, while cursors that link between YT and XY display modes make it easy to investigate phase relationships and Safe Operating Area violations. Select from 53 automatic measurements using a graphical palette that logically organizes measurements into Amplitude, Time, Histogram, and Communications categories. Gather further insight into your measurement results with statistical data such as mean, min, max, standard deviation, and population.

Define and apply math expressions to waveform data for on-screen results in terms that you can use. Access common waveform math functions with the touch of a button. Or, for advanced applications, create algebraic expressions consisting of live waveforms, reference waveforms, math functions, measurement values, scalars, and user-adjustable variables with an easy-to-use calculator-style editor.

With deep acquisition memory, margin testing can be done over many cycles and long duration trends in the data can be observed. Plus, data from the oscilloscope can be captured into Microsoft Excel using the unique Excel toolbar, and formatted into custom reports using the Word toolbar provided with the MSO/DPO70000 Series.

Automated tools to increase measurement throughput

Ease of use and measurement throughput are key when a large number of measurements must be completed with a performance oscilloscope. MSO70000 Series come standard with the DPOJET Advanced Jitter and Eye Diagram measurement application, providing the tools you need to quickly perform a high volume of measurements and collect statistics. DPOJET Essentials is standard on the DPO70000 Series with the DPOJET advanced version available as an option. Application-specific measurement packages are also available that extend DPOJET and perform the extensive set of tests required by industry standard groups. User-defined measurements can be added to DPOJET using the Application Developers Kit (ADK) that comes standard with the oscilloscope.



DPOJET Jitter and Eye Diagram Analysis – Simplify identifying signal integrity concerns, jitter, and their related sources with DPOJET software. DPOJET provides the highest sensitivity and accuracy available for real-time oscilloscopes.

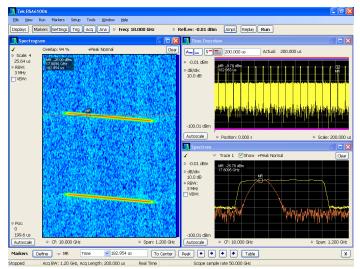
To support the DPO7OE1 optical probe, DPOJET now also provides optical measurements, such as Extinction Ratio (ER), Average Optical Power (AOP), Optical Modulation Amplitude (OMA), Optical High value, and Optical Low value.

Error detector

When performing receiver testing on a serial transceiver, a BER measurement is often required. The MSO/DPO70000 series offer an optional built-in error detector function for 8b/10b-encoded signals. The built-in error detector comes with presets for testing PCle, USB3.0, and SATA signals up to 6 Gb/s. The error detector settings can be customized to work with a generic 8b/10b-encoded signal and can be set to detect bit, character, or frame errors. When an error is detected, the scope will trigger and display the waveform bits where the error occurred.

RF and vector signal analysis

When vector signal analysis of RF or baseband signals is needed, the optional SignalVu® application enables measurements in multiple domains (frequency, time, phase, modulation) simultaneously. SignalVu® measurements are fully correlated with the scope's time domain acquisition and triggering. Time domain events, such as commands to an RF subsystem, can be used as trigger events, while the subsystem's RF signal can be seen in the frequency domain. SignalVu also provides wireless standards measurements such as IEEE 802.11 a/b/g/j/p/n/ac that can be correlated in the time domain ¹.



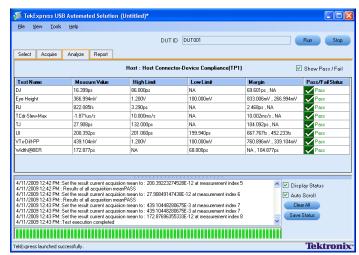
SignalVu® Vector Signal Analysis – Easily verify wide-bandwidth designs such as wideband radar, high data-rate satellite links, WLAN 802.11, or frequency-hopping radios and characterize wideband spectral events. SignalVu® combines the functionality of a vector signal analyzer, a spectrum analyzer, and the powerful triggering capabilities of the MSO/DPO70000 Series – all in a single package.

TekExpress® software automation framework

The TekExpress® software automation framework has been developed for automated one-button testing of high-speed serial data standards. TekExpress® efficiently executes the required tests for many serial standards such as SATA, SAS, MIPI® C-PHY, MIPI® D-PHY, MHL, MIPI® M-PHY, PCI Express®, USB 3.0, DisplayPort, and 10GBASE-T Ethernet. Run on an external Windows PC, the TekExpress® software orchestrates the instrument setup and control sequences to provide complete test results for complete design validation.

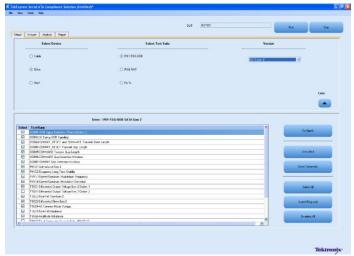
Beyond using the TekExpress® framework, custom applications that you develop yourself using application development environments such as MATLAB® can further extend the tool set of the MSO/DPO70000 Series.

Characterization measurements depend upon accuracy and repeatability. The wide bandwidth and unmatched signal fidelity of the MSO/DPO70000 analog front end ensures that your signal quality measurements such as rise times are faithful and amplitude correct with flatness of ± 0.5 dB.

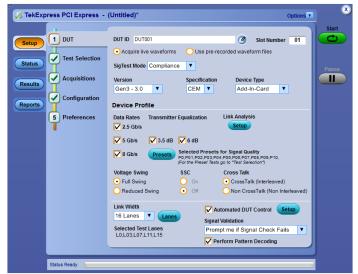


TekExpress® USB 3.0 Automated Test Software (Option USB-TX) – TekExpress® USB 3.0 provides an automated, simple, and efficient way to test USB 3.0 transmitter and receiver hosts and devices consistent with the requirements of the SuperSpeed Universal Serial Bus Electrical Compliance Test Specification. The application automates selection of appropriate fixture de-embed, CTLE and reference channel emulation filters and measurement selections based on device type, test type, test points, and selected probes. In addition, USB-TX leverages DPOJET allowing debug and advanced characterization of USB 3.0 solutions.

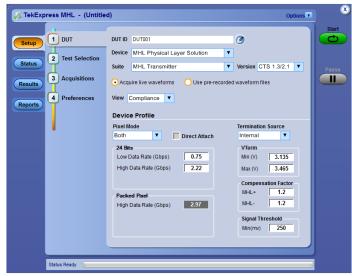
¹ Also check http://www.tek.com/signalvu for the latest information.



TekExpress® SATA Automated Compliance Test Software – Complete support for SATA Gen1/2/3 defined test suites for transmitters and receivers. Reduce your compliance test time by approximately 70% with simple, efficient automation of all required test suites with TekExpress® software. Also included is auto-recognition of all required test equipment, precise DUT/Host control, and one-button testing.



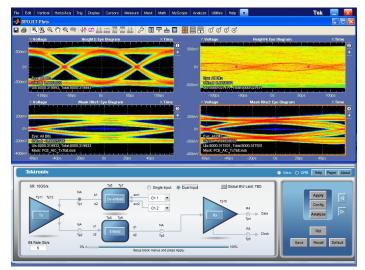
TekExpress® PCI Express Gen 1/2/3 Automated Test Software (Option PCE3) - Provides the most comprehensive solution for PCI Express Gen 1/2/3 transmitter compliance testing as well as debug and validation of PCI Express devices against the PCI-SIG specifications. The application automates selection of appropriate fixture deembed and reference channel emulation filters and measurement selections based on test type, device data rate, transmitter equalization, link width, and selected probes. In addition, the Option PCE3 application includes a TekExpress compliance automation solution that integrates the PCI-SIG's Sigtest test software with Tektronix' DPOJET-based PCI Express Jitter and Eye Diagram & SDLA Serial Data Link Analysis Visualizer analysis tools for debug. Results are presented in a comprehensive HTML format for engineering test documentation.



TekExpress® MHL Advanced Analysis and Compliance Software (Option MHD) - Provides the most comprehensive solution for MHL 1.0/2.0/1.3/2.1 compliance testing as well as debug and validation of MHL devices against the latest MHL specifications. The application automates Transmitter, Sink and Dongle Electrical tests. Results are presented in a comprehensive HTML format for engineering test documentation

Custom filter and de-embed capability

Create your own filters or use the filters provided as standard with the MSO/DPO70000 Series to enhance your ability to isolate or remove a component of your signal (noise or specific harmonics of the signal). These customizable FIR filters can be used to implement signal-processing techniques, such as removing signal pre-emphasis or minimizing the effects of fixtures and cables connected to the device under test. Using the optional Serial Data Link Analysis Visualizer (SDLA64) application, you can gain further insight into serial data links with the capability to emulate the serial data channel from its S-parameters, remove reflections, cross-coupling, and loss caused by fixtures, cables, or probes, and open closed eyes caused by channel effects using receiver equalization techniques, such as CTLE, DFE, FFE. IBIS-AMI models for silicon-specific receiver equalization can be used to observe on-chip behavior.



SDLA - Serial Data Link Analysis Visualizer (Option SDLA64) - Offers the capability to emulate the serial data channel, de-embed fixtures, cables, or probes, and add or remove equalization. Option SDLA64 also provides processing of waveforms with IBIS-AMI Receiver Equalization, or CTLE, FFE and/or DFE equalization. DPOJET provides advanced measurement and jitter analysis of the resulting waveforms.

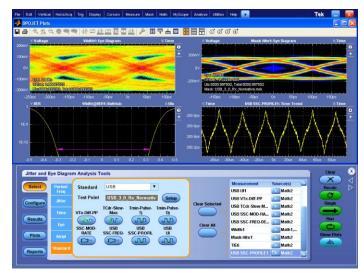
Application-specific solutions - enable standard-specific certification, measurement automation, and extended signal analysis

Accurate, Simple, and Customizable Physical Layer Certification Testing -For designers with industry-standard certification needs, standard-specific compliance and analysis modules that configure the pass/fail waveform mask and measurement limit testing are available as options on the MSO/ DPO70000 Series. Modules are available for PCI Express®, DDR Memory, Serial ATA, SAS, HDMI, Ethernet, DisplayPort, MIPI® C-PHY, MIPI® D-PHY and M-PHY, Power Supplies, and USB.

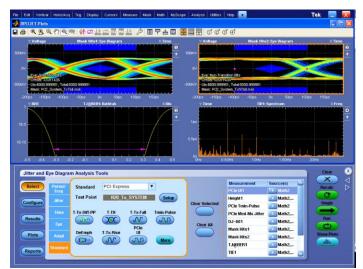
See the following list for highlights of the available application-specific solutions:



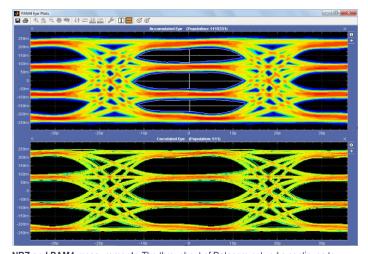
DDR Memory Bus Analysis (Option DDRA) - Automatically identify DDR1, LPDDR, LPDDR2, LPDDR3, DDR2, DDR3, DDR4, and GDDR3 Reads and Writes and makes JEDEC conformance measurements with pass/fail results on all edges in every Read and Write burst. DDRA provides capabilities for measurements of clock, address, and control signals. In addition to enabling conformance testing DDRA with DPOJET is the fastest way to debug complex memory signaling issues. DDRA can also use the Command/Address lines to trigger on specific read/write states when running on the MSO70000 Series Mixed Signal Oscilloscope, which offers 16 channels of digital logic



USB 3.0 Transmitter Test Solution (Option USB3) - Perform verification, characterization, and debug of USB 3.0 devices. Measurements are implemented in DPOJET and are compliant to the USB 3.0 specification. For compliance and automation, USB-TX is available.

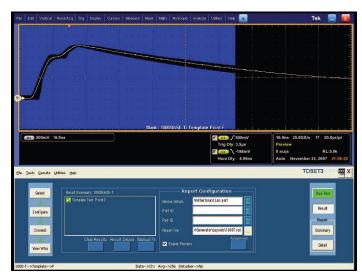


PCI Express® Transmitter Compliance and Debug (Option PCE3) - Analyze the performance of your PCI Express® Rev 1.0, 2.0, or 3.0 (draft spec) design with comprehensive test support. Using DPOJET, Option PCE3 enables tests that conform to PCI-SIG standards.

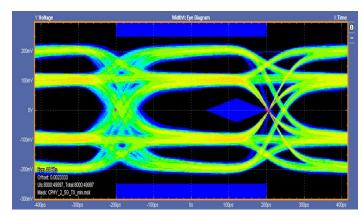


NRZ and PAM4 measurements-The throughput of Datacom networks continues to increase. Tek's DPO72504DX and DPO73304DX support up to 10GBASE KRn data rates. The powerful combination of the DPO70000, DPOJET Jitter and Noise Analysis, and the SDLA Serial Data Link Analysis tool performs accurate de-embedding and eye diagram analysis for Datacom standards.

For more information on PAM4 testing, please refer to the DPO70000SX datasheet and related PAM4 documents.



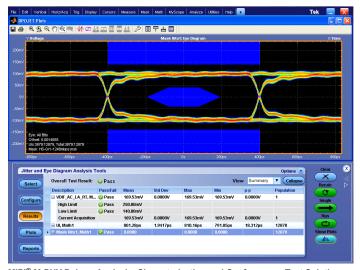
Ethernet Compliance Test Solution (Option ET3) - Receive full PHY layer support for Ethernet variants 10BASE-T, 100BASE-TX, and 1000BASE-T with the comprehensive, integrated Tektronix® Ethernet tool set. Analog verification, automated compliance software, and device characterization solutions are all included.



C-PHY uses a unique mechanism for clock recovery. C-PHY 1.0 implements a custom clock recovery algorithm referred to as triggered eye. In this model, the first zero crossing of the four differential signals is used as a trigger point for clock recovery and rendering the eye diagram. The eye mask is optimally placed for maximum eye opening where the eye height is measured. Because of the triggered eye mechanism, all the jitter at the trigger point (zero crossing) is swallowed and reflected on the other side. Jitter and eye diagram rendering performed over the entire record length helps designers better characterize devices by displaying anomalies of the device over an extended period. The software allows you to run the eye diagram analysis for 3M UI and overnight runs for a detailed characterization.



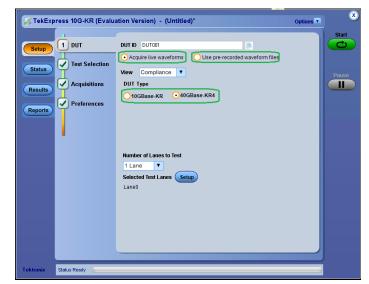
MIPI® D-PHY Characterization and Analysis Solution (Option D-PHY) - Verify to the D-PHY specification by rapidly characterizing and discovering sources of jitter and signal integrity concerns using the fully flexible and customizable test setup. Using DPOJET, Option D-PHY enables transmitter high-speed data-clock timing measurements, along with a full range of electrical characteristics in high-speed or low-power modes



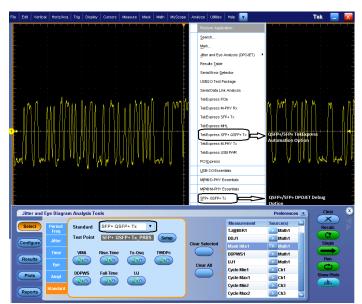
MIPI® M-PHY Debug, Analysis, Characterization and Conformance Test Solution (Option M-PHY) - Verify to the M-PHY specification by rapidly characterizing and discovering sources of jitter and signal integrity concerns. Using DPOJET, Option M-PHY enables transmitter signaling and timing measurements such as differential transmit eye diagrams, rise and fall times, slew rate, amplitude parameters, common mode voltages on each lane for both the large and small amplitude configurations, as well as the terminated and unterminated cases.



XGbT 10GBASE-T Automated Compliance Software - Quickly perform 10GBASE-T measurements per the IEEE 802.3an-2006 standard including Power Spectral Density (PSD), Power Level, and Linearity, with a simplified instrument configuration. XGbT provides flexible control over test configurations and analysis parameters, enabling more in-depth device characterization.



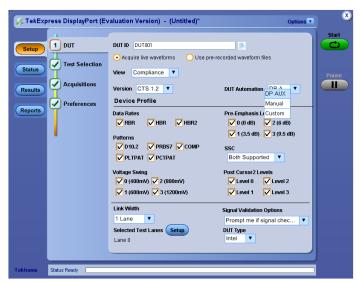
10GBASE-KR/KR4 Compliance and Debug Solution (Option 10G-KR) - Automated compliance measurements for IEEE 802.3ap-2007 specifications. This option includes an automated compliance solution and debugging with DPOJET. The automated test setup measures transmitter equalization levels generating 12 results for each tap and 120 results for 9 different measurements in approximately 15 minutes.



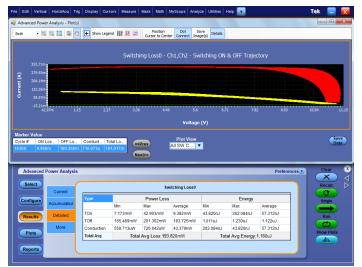
Tektronix SFP+ QSFP+ Tx is developed on a Real Time Oscilloscope platform, which is the platform of choice for engineers designing their products around SFF-8431 & SFF-8634 technology. Option SFP-TX and SFP-WDP enable both an Automation Solution (for Compliance) and DPOJET Option (for Debug), Users can save up to 80% on testing time compared to manual testing. TWDPc - Transmitter Waveform Distortion Penalty for Copper Measurements are available with Option SFP-WDP. SFF-8431 SFP+ TWDPc based MATLAB code is integrated into the SFP-WDP option to make sure Engineers can use this measurement in the automated setup.



HDMI Compliance Test Solution (Option HT3) - A fast, efficient solution for HDMI compliance measurement challenges, no matter if you are working on a Source, Cable, or Sink solution. This application provides all the HDMI compliance test solutions you need to ensure quality and interoperability.



DisplayPort Compliance Test Solution (Option DP12) – Supports DisplayPort Compliance Test Standard (CTS) source test with four-line simultaneous testing using the Tektronix® P7300SMA Series probes and DisplayPort software. Detailed test reports with waveform plots, pass/fail results, and margin analysis are included.



Power Measurement and Analysis Software (Option PWR) - DPOPWR, Advanced Power Measurement and Analysis software allows the user to configure multiple measurements with custom defined settings, measure and analyze power dissipation in switching devices, and magnetic parameters in a single acquisition. The Trajectory plot computes turn-on loss, turn-off loss and Conduction loss parameters for each cycle. Measurements such as Phase, Conduction loss, amplitude, and Voltage harmonics provide more insight to Input/Output characterization of power supplies. A single mht format file with append feature provides an easy way of generating reports which include measurements, test results, and plot images.

Certification

This is the start of your concept. Before a product can go to market, you often need to complete a series of certification tests on the industrystandard high-speed serial buses in your design. These tests can involve many hours of wrestling with test fixtures, reading certification documents. and collecting sufficient data to validate that your system passes the required tests.

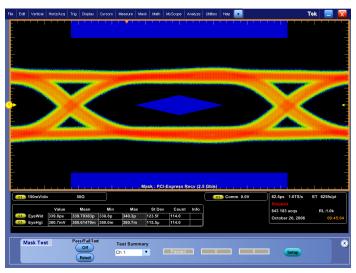
MSO70000 - A dedicated solution configured for today's high-speed serial design challenges

The MSO70000 Mixed Signal Oscilloscopes are specially configured to address high-speed serial data designs by encapsulating many of the serial domain features needed for high-speed serial verification and characterization. These standard features on the MSO70000 Series are options on the DPO70000 Series.

Serial pattern triggering – Real-time serial pattern triggering and protocol decode with built-in clock recovery recovers the clock signal, identifies the transitions, and decodes characters and other protocol data. You can see the 8b/10b bit sequences decoded into their words for convenient analysis, and set the desired encoded words for the serial pattern trigger to capture. With pattern lock triggering, the MSO70000 Series can synchronize to long serial test patterns with data rates up to 6.25 Gb/s and remove random jitter.

DPOJET jitter, timing, and eye diagram analysis – The MSO70000 Series features the highest-accuracy jitter and timing measurements as well as comprehensive analysis algorithms. Tight timing margins demand stable, low-jitter designs. You can make jitter measurements over contiguous clock cycles on every valid pulse in a single-shot acquisition. Multiple measurements and trend plots quickly show system timing under variable conditions, including Random, Deterministic, and Bounded Uncorrelated Jitter separation.

Communications mask testing - Provides a complete portfolio of masks for verifying compliance to serial communications standards. Over 150 masks including the following standards are supported – PCI Express®, ITU-T/ANSI T1.102, Ethernet IEEE 802.3, ANSI X3.263, Sonet/ SDH, Fibre Channel, InfiniBand, USB, Serial ATA, Serial Attached SCSI, IEEE 1394b, RapidIO, OIF Standards, Open Base Station Architecture Initiative (OBSAI), Common Public Radio Interface (CPRI).



Communications mask testing

62 MS record length – 62 MS on all four channels provides a longer time sequence at high resolution. Optional record lengths up to 125 MS for the 4, 6, and 8 GHz models, 250 MS for the 12.5 through 20 GHz models and 500 MS (4 channels)/1 GS (2 channels) on 23 to 33GHz models extend the acquisition time sequence.

With standard features that extend the functionality of the Tektronix DPO70000 Series to address high-speed serial signal analysis and certification, the MSO70000 Series offers a specialized instrument that efficiently addresses your design challenges.

Protocol Decode for High Speed Serial buses

The MSO/DPO70000 Series oscilloscopes provide optional protocol analysis for HSS buses such as PCI Express gen 1/2/3, MIPI D-PHY (CSI, DSI) and 8b/10b-encoded buses. With these capabilities, bit sequences can be decoded into familiar commands and data packets for faster analysis. With the PCI Express decoder, the data is displayed in a protocolaware view using characters and terms from the standard, such as the ordered sets: SKP, Electrical Idle, and EIEOS

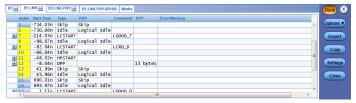


Table View of the Bus Protocol. The results table provides a protocol view of the bus and with a mouse click allows correlation of what is happening in the physical layer to what is happening in the protocol layers.



Protocol and Electrical Views of an HSS Bus. The data in the results table and the acquired waveform are time correlated, enhancing the ability to identify possible causes of protocol errors due to electrical signaling.

Both the 8b/10b serial bus trigger and the advanced search and mark feature on the oscilloscope are integrated with the HSS protocol decode to quickly isolate events of interest in a HSS data stream.

User-selectable bandwidth limit filters

While wide bandwidth is needed to characterize your high-speed serial designs, certification testing can require a specific instrument bandwidth appropriate for the signal's data rate in order to correlate test results between different test labs. The MSO/DPO70000 Series feature userselectable bandwidth limiting filters. Using these bandwidth limit filters which range from 500 MHz to 32 GHz, you will ensure that your measurement is done using the bandwidth specified by the industry standard.

Debugging

Throughout the design cycle, MSO/DPO70000 Series oscilloscopes provide the ability to debug malfunctioning subsystems and isolate the cause. With the high waveform capture rate of FastAcq® you can quickly identify signal anomalies that occur intermittently - saving minutes, hours, or even days by quickly revealing the nature of faults so sophisticated trigger modes can be applied to isolate them. Using Pinpoint® triggers, infrequent events such as glitches or signal runts caused by bus contention or signal integrity issues can be captured, analyzed, and then eliminated.

FastAcq® – Expedites debugging by clearly showing imperfections

More than just color grading or event scanning, the FastAcq® proprietary DPX® acquisition technology captures signals at more than 300,000 waveforms per second on all four channels simultaneously, dramatically increasing the probability of discovering infrequent fault events. And with a simple turn of the intensity knob you can clearly "see a world others don't see", displaying the complete picture of your circuit's operation. Some oscilloscope vendors claim high waveform capture rates for short bursts of time, but only MSO/DPO70000 Series oscilloscopes, enabled by DPX® technology, can deliver these fast waveform capture rates on a sustained basis.

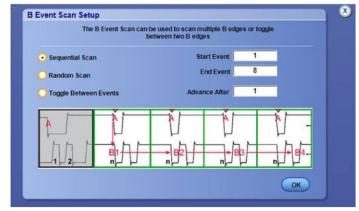
Pinpoint® trigger

Whether you're trying to find a problem signal or need to isolate a section of a complex signal for further analysis, like a DDR Read or Write burst, Tektronix Pinpoint® triggering provides the solution. Pinpoint® triggering allows selection of virtually all trigger types on both A and B trigger events delivering the full suite of advanced trigger types for finding sequential trigger events. Pinpoint® triggers provide trigger reset capabilities that begin the trigger sequence again after a specified time, state, or transition so that even events in the most complex signals can be captured. Other oscilloscopes typically offer less than 20 trigger combinations; Pinpoint® triggering offers over 1400 combinations, all at full performance. Visual Trigger extends the Pinpoint Triggering's capabilities, adding another level of trigger qualification to find important events in a wide variety of complex signals.

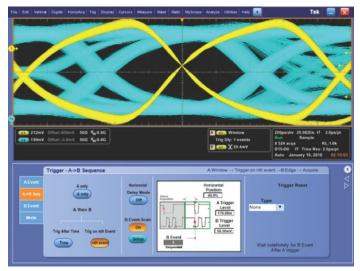
With Enhanced Triggering, trigger jitter is reduced to <100 fs. With this stability at the trigger point, the trigger point can be used as a measurement reference.

B scan event trigger

Users who wish to create eye diagrams from data bursts synchronized or initiated by an A event will find the B Event Scan trigger function especially useful. B Event Scan is an A to B trigger sequence that will trigger and capture burst event data of interest defined by the B Event setup menu. Captured bits can be scanned in a sequential or randomized fashion, alternatively the trigger can toggle between two successive B trigger events.



B Event Scan identifies specific events to build an eye diagram.



Use B Event Scan trigger on DDR DQS edges used to construct an eye diagram of all bits in a burst.

Logic pattern triggering

Logic pattern triggering allows logic qualification that controls when to look for faults and ignore events that do not occur during the desired state. On the MSO70000 Series, up to 20-bit wide logic pattern triggering enhances the Pinpoint® trigger capabilities by helping you isolate the specific system state and analog events that are causing system failure.

Digital A then analog B triggering (MSO70000 Series only)

Advanced triggering capabilities include Digital A then Analog B to help you to identify a specific digital pattern or system state and then wait for an analog event such as a runt pulse to trigger the acquisition.

Integrated logic channels (MSO70000 Series only)

The MSO70000 Series extends the debug capabilities of a 4-channel oscilloscope with an additional 16 logic channels that can be used to provide system level context when the fault occurs. This context, such as an illegal system state or error, may be the clue that leads to the root cause. When other oscilloscopes require you to use a logic analyzer to see the digital data you need to solve your debugging challenge, the MSO70000 Series can effectively debug and verify many digital timing issues in the system more quickly and easily. With 80 ps timing resolution and channel-to-channel skews of as little as 160 ps, the integrated logic channels allow you to view and measure time-correlated digital and analog data in the same display window.



Integrated Logic Channels - Provide time-correlated analog and digital visibility for system debugging.

FastFrame[™]

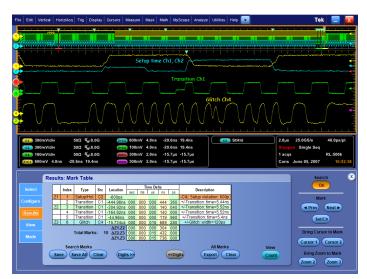
When the key events you are interested in are widely spaced in time, such as bursts of activity on a bus, the FastFrame[™] segmented memory feature on the MSO/DPO70000 Series enables you to capture the events of interest while conserving acquisition memory. Using multiple trigger events, FastFrame[™] captures and stores short bursts of signals and saves them as frames for later viewing and analysis. On the MSO70000 Series, FastFrame[™] and bus or logic triggering enable you to capture your fastest, bursty signals on the analog channels at the highest sample rate while the logic channel trigger recognizes the bus cycle of interest. Capturing thousands of frames is possible, so long-term trends and changes in the bursting signal can be analyzed. Signals captured with FastFrame[™] can also be post-processed using waveform averaging or envelope mode.

iCapture[™] (MSO70000 Series only)

When an anomaly is seen on digital lines, iCapture[™] delivers new insight into the analog behavior of the digital signals. With iCapture[™], you can route any 4 of the 16 logic channels to the MSO70000 Series' analog acquisition system so that these signals can be viewed in finer detail. The unique multiplexer circuitry of iCapture™ provides simultaneous digital and analog views of signals without needing to move the logic probe or double probe the circuit.

Advanced search and mark

Isolating the key event causing your system failure can often be a tedious task. With the Advanced Event Search and Mark feature standard on the MSO/DPO70000 Series, examining data and highlighting important events, skipping the unimportant ones, and enhancing the comprehension of event relationships is made easy. With ASM, you'll be able to navigate through long record length acquisitions effortlessly and quickly locate the event you have been trying to find. Advanced searches can be defined individually or using the scope's trigger settings as the definition for the search. Even Visual Trigger areas can be used as part of the ASM criteria.



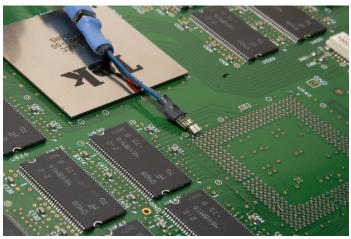
Advanced Search and Mark - Highlights important events and provides convenient previous and next buttons and mouse clicks to navigate between events of interest effortlessly.

Embedded serial bus (I²C, SPI, RS-232/422/485, UART, USB) decoding and triggering

The MSO/DPO70000 Series instruments provide integrated support for a broad range of serial buses – I²C, SPI, RS-232/422/485/UART, and USB. This support for up to 16 separate serial buses enables you to monitor or debug subsystems and components, such as frequency synthesizers, D/A converters, and Flash Memory that are controlled or monitored through serial control buses. While monitoring or debugging these serial buses alone is relatively easy, decoding events on the serial bus can also enable more complex system-level debugging. When you experience an issue with a higher-speed serial interface, the clue to what is going wrong may be found by using the serial bus decode feature to observe the data on your I²C, SPI, RS-232/422/485/UART, or USB interface.

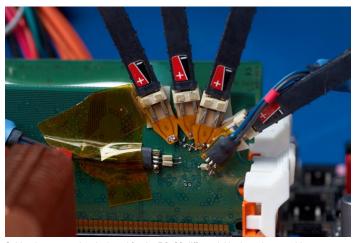
Probing - analog and digital

Often the biggest challenge in debugging a system is getting access to the required signals. Tektronix offers a wide array of probing solutions, including the P7600 and P7500 TriMode™ probing system with bandwidths that are perfectly matched to the MSO/DPO70000 Series. The P7600 and P7500 TriMode[™] probes allow you to switch among differential, single ended, and common-mode measurements without moving the probe from its connection points. The P7600 series combines low noise, 33 GHz bandwidth and the convenience of TriMode[™] probing. The P7500 Series offers probes with performance from 4 GHz to 25 GHz and offers several low-cost solder tips with quick connection features that allow moving the probe to various solder points fast and easy.



The low-cost solder tips available for the P7500 TriMode[™] probes allow quick connection so moving the probe to various solder points is fast and easy.

On the MSO70000 Series, the P6780 differential, P6750 high-density D-Max®, and P6717A general-purpose logic probes provide connectivity to low-speed and high-speed digital signals with low loading, small size, and a range of accessories for soldering or browsing.



Solder tip accessories designed for the P6780 differential logic probes provide access to signals on tightly spaced vias and fine-pitched components.

DPO70E Series Optical Probes

The DPO70E Series Optical probes can be used as an Optical Reference Receiver for high speed serial data signals (using selectable Bessel-Thomson ORR filters), or can be used as a conventional O/E converter for general wide-bandwidth optical signal acquisition. The DPO70E Series is compatible with DPO/MSO70000 C/DX/SX models. Connected to TekConnect channels for up to 33 GHz bandwidth.



DPO70E1 33 GHz Optical Probe

Production testing

In addition to assisting engineers with design tasks, the MSO/DPO70000 Series allow test engineers to test analog and digital signals with a wide range of clock speeds and data rates. Rackmount options are available for mounting the MSO/DPO70000 Series into an EIA standard 19 inch (487 mm) rack. An IEEE 488.2 standard GPIB interface is standard on all models.

LXI Class C

Using the LXI Web Interface, you can connect to the MSO/DPO70000 Series through a standard web browser by simply entering the oscilloscope's IP address in the address bar of the browser. The web interface enables viewing of instrument status and configuration, as well as status and modification of network settings. All web interaction conforms to the LXI Class C specification.

OpenChoice® analysis tools

The OpenChoice® Software allows you to customize your test and measurement system with familiar analysis tools. The analysis and networking features of the OpenChoice® software add more flexibility to Tektronix MSO/DPO70000 Series oscilloscopes: Using the fast embedded bus, waveform data can be moved directly from acquisition to analysis applications on the Windows® desktop at much faster speeds than conventional GPIB transfers.

Implementation by Tektronix of industry-standard protocols, such as TekVISA™ interface and ActiveX controls, are included for using and enhancing Windows® applications for data analysis and documentation. IVI instrument drivers are included to enable easy communication with the oscilloscope using GPIB, RS-232, and LAN connections from programs running on the instrument or an external PC.

The Application Development Kit (ADK) extends the OpenChoice® framework to support custom end-user and third-party application development. ADK documentation describes how to implement the Data Store Public Interface to speed internal transfer of waveform data through user-created data processing algorithms and display the results in real time on the oscilloscope screen. The Data Store Public Interface is >2X faster than traditional GPIB-based data transfer techniques. The Data Store Public Interface is accessible through MathWorks MATLAB® or .NET languages such as C# or Visual Basic. Other features of the ADK include a DPOJET plug-in that enables users to add custom measurements to this market-leading timing and jitter analysis tool. The ADK provides comprehensive documentation and coding examples to aid the user in developing their own unique analysis tool kit to quickly capture and analyze their signals.

Research

With industry-leading acquisition speed and signal-to-noise ratio performance, the MSO/DPO70000 Series can provide researchers with tools that allow them to capture, display, and analyze high-speed and transient signals with unmatched precision.

Full control of acquisition and display parameters

You have full control of the instrument's acquisition modes. Choose the mode you need to do your job the fastest: Automatic, Constant Sample Rate, or Manual settings. When you are doing signal exploration and want a lively signal, the default Automatic mode provides you with the liveliest display update rate. If you want the highest real-time sample rate that will give you the most measurement accuracy, then the Constant Sample Rate mode is for you. It will maintain the highest sample rate and provide the best real-time resolution. Finally, the Manual mode ensures direct and independent control of the sample rate and record length for applications requiring specific settings.

Document tools

The OpenChoice® architecture provides a comprehensive software infrastructure for faster, more versatile operations. Data transfer utilities, such as the Excel or Word toolbar plug-ins can be used to simplify analysis and documentation on the Windows® desktop or on an external PC.

Unmatched usability

The MSO/DPO70000 Series instruments excel in usability with a suite of productivity features, such as a touch screen, flat menu structures, intuitive graphical icons, knob-per-channel vertical controls, right clicks, mouse wheel operation, and familiar Windows-based controls.

Remote Desktop

When your oscilloscope is connected to a network, use the Windows® Remote Desktop utility to access your oscilloscope from across the lab or across the globe.

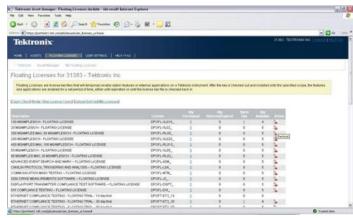
MyScope® - Create your own control windows

Easily create your own personalized "toolbox" of oscilloscope features in a matter of minutes using a simple, visual, drag-and-drop process. Once created, these custom control windows are easily accessed through a dedicated MyScope® button and menu selection on the oscilloscope button/menu bar, just like any other control window. You can make an unlimited number of custom control windows, enabling each person who uses the oscilloscope in a shared environment to have their own unique control window. MyScope® control windows will benefit all oscilloscope users, eliminating the ramp-up time that many face when returning to the lab after not using an oscilloscope for a while, and enables the power user to be far more efficient. Everything you need is found in one control window rather than navigating through multiple menus to repeat similar tasks.

Option asset management: floating or fixed

Many Tektronix application solutions and hardware options are enabled with an encrypted license key that is entered through the oscilloscope's Utilities menu. You now have two options. The first option is a fixed license applied to a specific scope serial number and is permanently enabled. A fixed license cannot be moved from one oscilloscope to another.

The second option is a floating license. Floating licenses provide the capability to move a license-key enabled option from one oscilloscope to another. This capability helps users with distributed teams and several Tektronix MSO/DPO70000, or DPO7000, and MSO/DPO5000 Series oscilloscopes to better manage their assets and deploy applications or other options such as extended memory to the oscilloscope where it is needed.



This view in the floating license system identifies the license's current user and location allowing you to easily manage your floating license inventory.

Managing and deploying floating licenses uses an easy online licensing management system. All floating license management functions are maintained on Tektronix secure servers and no infrastructure or your company IT department involvement is necessary. Simply utilize your myTek account to access, track, and deploy your oscilloscope floatinglicense enabled options.

Performance you can count on

Depend on Tektronix® to provide you with performance you can count on. All Tektronix® products are backed with industry-leading service and support.

Specifications

All specifications are guaranteed unless noted otherwise. All specifications apply to all models unless noted otherwise.

Model overview

	DPO70404C, MSO70404C	DPO70604C, MSO70604C	DPO70804C, MSO70804C	DPO71254C, MSO71254C	DPO71604C, MSO71604C	DPO72004C, MSO72004C	DPO72304DX, MSO72304DX	DPO72504DX, MSO72504DX	DPO73304DX, MSO73304DX
Analog channels	4	4	4	4	4	4	4	4	4
Digital channels (MSO70000 Series only)	16	16	16	16	16	16	16	16	16
Analog bandwidth (user-selectable DSP enhance) (–3 dB)	4 GHz	6 GHz	8 GHz	12.5 GHz	16 GHz	20 GHz	23 GHz (2 Ch) 23 GHz (4 Ch)	25 GHz (2 Ch) 23 GHz (4 Ch)	33 GHz (2 Ch) 23 GHz (4 Ch)
Hardware Analog Bandwidth (-3 dB)	4 GHz	6 GHz	8 GHz	12.5 GHz	16 GHz (typical)	16 GHz (typical)	23 GHz	25 GHz	33 GHz
Rise time (typical)	10% to 90%: 98 ps 20% to 80%: 68 ps	10% to 90%: 65 ps 20% to 80%: 45 ps	10% to 90%: 49 ps 20% to 80%: 34 ps	10% to 90%: 32 ps 20% to 80%: 22 ps	10% to 90%: 24.5 ps 20% to 80%: 17 ps	10% to 90%: 18 ps 20% to 80%: 14 ps	10% to 90%: 17 ps 20% to 80%: 13 ps	10% to 90%: 16 ps 20% to 80%: 12 ps	10% to 90%: 13 ps 20% to 80%: 9 ps
Sample rate (1, 2 ch) (maximum sample rate is 50 GS/s on digital channels routed to an analog channel through the iCapture™ analog mux)	25 GS/s	25 GS/s	25 GS/s	100 GS/s	100 GS/s	100 GS/s	100 GS/s	100 GS/s	100 GS/s
Sample rate (3, 4 ch)	25 GS/s	25 GS/s	25 GS/s	50 GS/s	50 GS/s	50 GS/s	50 GS/s	50 GS/s	50 GS/s
Sample rate (ET/IT mode)	5 TS/s	5 TS/s	5 TS/s	10 TS/s	10 TS/s	10 TS/s	10 TS/s	10 TS/s	10 TS/s
Record length, points (each channel, standard)	31.25 M 62.5 M (MSO70000 Series)	31.25 M 62.5 M (MSO70000 Series)	31.25 M 62.5 M (MSO70000 Series)	31.25 M 62.5 M (MSO70000 Series)	31.25 M 62.5 M (MSO70000 Series)				
Record length (each channel, Opt. 5XL, DPO70000 series)	62.5 M	62.5 M	62.5 M	62.5 M	62.5 M				
Record length (each channel, Opt. 10XL)	125 M	125 M	125 M	125 M	125 M				
Record length (each channel, Opt. 20XL)	N/A	N/A	N/A	250 M	250 M	250 M	250 M	250 M	250 M
Record length (each channel, Opt. 50XL)	N/A	N/A	N/A	N/A	N/A	N/A	500 M each channel, 1G on 2 channels	500 M each channel, 1G on 2 channels	500 M each channel, 1 G on 2 channels
Timing resolution	40 ps (25 GS/s)	40 ps (25 GS/s)	40 ps (25 GS/s)	10 ps (100 GS/s)	10 ps (100 GS/s)	10 ps (100 GS/s)	10 ps (100 GS/s)	10 ps (100 GS/s)	10 ps (100 GS/s)
Duration at highest sample rate (standard)	1.25 ms 2.5 ms (MSO70000 Series)	1.25 ms 2.5 ms (MSO70000 Series)	1.25 ms 2.5 ms (MSO70000 Series)	0.31 ms 0.61 ms (MSO70000 Series)	0.31 ms 0.61 ms (MSO70000 Series)	0.31 ms 0.61 ms (MSO70000 Series)	0.31 ms 0.61 ms (MSO70000 Series)	0.31 ms 0.61 ms (MSO70000 Series)	0.31 ms 0.61 ms (MSO70000 Series)
Duration at highest sample rate (Opt. 5XL, DPO70000 series)	2.5 ms	2.5 ms	2.5 ms	0.63 ms	0.63 ms	0.63 ms	0.63 ms	0.63 ms	0.63 ms
Duration at highest sample rate (Opt. 10XL)	5.0 ms	5.0 ms	5.0 ms	1.3 ms	1.3 ms	1.3 ms	1.3 ms	1.3 ms	1.3 ms

Model overview

	DPO70404C, MSO70404C	DPO70604C, MSO70604C	DPO70804C, MSO70804C	DPO71254C, MSO71254C	DPO71604C, MSO71604C	DPO72004C, MSO72004C	DPO72304DX, MSO72304DX	DPO72504DX, MSO72504DX	DPO73304DX, MSO73304DX
Duration at highest sample rate (Opt. 20XL)	_	_	_	2.5 ms	2.5 ms	2.5 ms	2.5 ms	2.5 ms	2.5 ms
Duration at highest sample rate (Opt. 50XL)	_	_	_	_	_	_	5 ms each channel, 10 ms 2 channels	5 ms each channel, 10 ms 2 channels	5 ms each channel, 10 ms 2 channels
Vertical noise (% of full scale) (50 mV/div, bandwidth filter on, max sample rate) (typical)	0.28%	0.32%	0.35%	0.36%	0.36%	0.56%	0.58%	0.58%	0.58%
Time base range (Auto mode)	20 ps/div to 1000 s/div	20 ps/div to 1000 s/div	20 ps/div to 1000 s/div	10 ps/div to 1000 s/div	10 ps/div to 1000 s/div	10 ps/div to 1000 s/div			
Timing resolution (ET/IT mode)	200 fs	200 fs	200 fs	100 fs	100 fs	100 fs	100 fs	100 fs	100 fs
Delta time measurement accuracy (RMS over <100 ns Duration; Single Shot; Signal Rise Time = 1.2 × Scope Rise Time; 100 mV/div, bandwidth filter on, max sample rate)	1.48 ps	1.33 ps	1.24 ps	1.23 ps	1.15 ps	1.43 ps	639 fs	639 fs	555 fs
Jitter noise floor (with BWE enabled) (typical)	340 fs	300 fs	300 fs	270 fs	270 fs	290 fs	<380 fs	<365 fs	<325 fs

Vertical system – Analog channels

,	
Bandwidth limit	Depending on instrument model: 33 GHz to 1 GHz in 1 GHz steps, or 500 MHz
	Depending on instrument model, hardware-only bandwidth settings at 33, 25, 23, 20, 16, 12.5, 8, 6, and 4 GHz
Channel-to-Channel isolation	Any two channels at equal vertical scale
	0 GHz to 10 GHz: ≥120:1
	>10 GHz to 12 GHz: ≥80:1
	>12 GHz to 15 GHz: ≥50:1
	>15 GHz to 20 GHz: ≥25:1
	>20 GHz to 33 GHz: ≥20:1
DC gain accuracy	±2% (of reading)
Channel delay (typical)	≤10 ps for any two channels at equal V/div and coupling on C models
	≤1 ps for any two channels at equal V/div and coupling on DX models
Effective number of bits (typical)	5.5 bits at 50 mV/div, bandwidth filter on, max bandwidth up to 13 GHz, max sample rate
Signal-to-Noise ratio (typical)	34 dB
Input coupling	DC (50 Ω), GND
Input resistance selection	50 Ω ±3%, 1 M Ω with TCA-1MEG adapter

Vertical system - Analog channels

Input sensitivity range

23 GHz, 25 GHz, and 33 GHz

models

6.25 mV/div to 600 mV/div (62.5 mV to 6 V full scale)

20 GHz models

20 to 500 mV/div (200 mV to 5 V full scale)

10 mV/div at 18 GHz (100 mV full scale)

All other models

10 mV/div to 500 mV/div (100 mV to 5 V full scale)

Maximum input voltage, 50 Ω

Also determined by TekConnect® accessory.

23 GHz, 25 GHz, and 33 GHz models

≤1.2 V_{FS}: ±1.5 V relative to the termination bias (30 mA maximum), ±5 V absolute maximum input.

>1.2 V_{FS}: 8.0 V.

All other models <5.0 V_{RMS} for \geq 100 mV/div; 1.0 V_{RMS} for <100 mV/div

Termination voltage range

23 GHz, 25 GHz, and 33 GHz

 \leq 1.2 V_{FS}: -3.5 V to +3.5 V

models

>1.2 V_{FS}: 0 V.

All other models 0 V only

Offset accuracy

10 mV/div to 99.5 mV/div

±(0.35% (offset value-position) + 1.5 mV + 1% of full scale)

100 mV/div to 500 mV/div

±(0.35% (offset value-position) + 7.5 mV + 1% of full scale)

Offset range

23 GHz, 25 GHz, and 33 GHz

models

All other models 10 mV/div: ±450 mV

> 20 mV/div: ±400 mV 50 mV/div: ±250 mV 100 mV/div: ±2.0 V 200 mV/div: ±1.5 V 500 mV/div: ±0.0 V

+3.4 V to -3.4 V

Passband flatness (20, 50, 100,

250 mV/div) (typical)

±0.5 dB to 50% of nominal bandwidth

Position range

±5 div

Vertical resolution

8 bit (11 bit with averaging)

Datasheet

Vertical system - Digital channels

Digital bandwidth

With P6780 logic probe 2.5 GHz With P6750 or P6717A logic 1 GHz

probe

Input resistance selection

With P6780 logic probe 20 k Ω to ground per side or 40 k Ω differential mode \pm 2.0%, 0.5 pF

With P6750 or P6717A logic

probe

 $20 \text{ k}\Omega \pm 1.0\%$, 3 pF

Trigger clock/qualifier input

Vertical resolution 1 bit

Thresholds One per channel, independently set

1

Threshold accuracy ±75 mV + 3% of threshold setting

Threshold resolution 5 mV

Threshold voltage range

With P6780 logic probe -2 to +4.5 V With P6750 or P6717A logic -1.5 to +4.0 V

probe

Minimum voltage swing 300 mV_{p-p}

±15 V nondestruct Maximum input voltage

Horizontal system

Channel-to-Channel deskew range ±75 ns

Time base accuracy ±1.5 ppm initial accuracy, aging <1 ppm per year

Time base delay time range -5.0 ks to 1.0 ks

Trigger jitter <100 fs_{RMS} (1 ps_{RMS} [typical] with enhanced triggering off)

Acquisition system - Analog channels

Acquisition modes

Sample Acquires and displays sampled values

From 2 to 10,000 waveforms can be included in an average waveform Average

Envelope From 1 to 2×109 waveforms included in min-max envelope

Hi-Res Real-time boxcar averaging reduces random noise and increases resolution

Peak detect Capture and display narrow glitches at all real-time sampling rates. Glitch widths: 1 ns at ≤125 MS/s; 1/sample rate at ≥250 MS/s

FastAcq® FastAcq® optimizes the instrument for analysis of dynamic signals and capture of infrequent events, capturing >300,000 wfms/s on

all TekConnect channels simultaneously, standalone configuration only

FastFrame[™] Acquisition memory divided into segments; maximum trigger rate >310,000 waveforms per second. Time of arrival recorded with

each event. Frame finder tool helps to visually identify transients. TekConnect channels only, standalone configuration only

Acquisition system - Analog channels

Roll mode Scrolls sequential waveform points across the display in a right-to-left rolling motion. Works at sample rates up to 10 MS/s with a

maximum record length of 40 MS. TekConnect channels only, standalone configuration only

Waveform database Accumulates waveform data providing a three-dimensional array of amplitude, time, and counts. TekConnect channels only,

standalone configuration only

Acquisition system - Digital channels

Maximum sample rate (all channels)

12.5 GS/s

Timing resolution

80 ps

Channel-to-Channel timing

uncertainty

<160 ps

Minimum detectable pulse width

<400 ps

Maximum number of buses

16

Number of channels per bus

Up to 24 (16 logic, 4 analog, 4 math)

Pinpoint® trigger system

Trigger sensitivity

Internal DC coupled 4% of full scale from DC to 50 MHz

> 10% of full scale at 4 GHz 20% of full scale at 8 GHz 50% of full scale at 11 GHz

Aux input 50 Ω (external trigger)

250 mV from DC to 50 MHz, increasing to 350 mV at 1.0 GHz

A event and delayed B event trigger types

Edge, glitch, width, runt, timeout, transition time, logic pattern, logic state, setup/hold, window - all except edge, pattern, and state can be logic state qualified by up to two channels

Main trigger modes

Auto, Normal, and Single

Trigger sequences

Main, Delayed by Time, Delayed by Events, Reset by Time, Reset by State, Reset by Transition. All sequences can include a

separate horizontal delay after the trigger event to position the acquisition window in time

Trigger coupling

DC, AC (attenuates <100 Hz) HF Rej (attenuates >20 kHz)

LF Rej (attenuates <200 kHz) Noise Reject (reduces sensitivity)

RF coupling (increases trigger sensitivity and bandwidth at the highest operating frequencies)

Trigger holdoff range

250 ns min to 12 s max

Trigger level range

Any channel ±120% of full scale from center of screen

±5 V **Auxiliary input**

Line 0 V, not settable

Datasheet

Pinpoint® trigger system

Clock recovery system

DPO Models Requires Option ST6G or Option MTH

MSO Models Standard

Clock recovery phase locked loop

bandwidth

Fixed at FBaud/1600

Clock recovery jitter (RMS) <0.25% bit period + 2 ps_{RMS} for PRBS data patterns

<0.25% bit period + 1.5 ps_{RMS} for repeating "0011" data pattern

Minimum signal amplitude needed

for clock recovery

1 div_{p-p} up to 1.25 Gbaud

1.5 div_{p-p} above 1.25 Gbaud

Tracking/Acquisition range ±2% of requested baud

Clock recovery frequency range 1.5 MBaud to 3.125 GBaud. Recovered clock and regenerated data available for use with a BERT.

Serial pattern trigger

DPO Models Requires Option ST6G

MSO Models Standard

NRZ-Encoded Data Up to 64 bit serial word recognizer, bits specified in binary (high, low, don't care) or hex format

Trigger on NRZ-encoded data up to 1.25 GBaud

8b/10b-Encoded Data Trigger on 8b/10b-encoded data at the following rates: 1.25 to 1.65, 2.1 to 3.2, 3.8 to 5.1, and 5.4 to 6.25 GBaud.

Pattern length up to 40 bits (1 to 4 valid 10-bit characters)

Alignment character is K28.5 (either disparity)

Communications-related triggers

Support for AMI, HDB3, BnZS, CMI, MLT3, and NRZ encoded communications signals. Select among isolated positive or negative

one, zero pulse form, or eye patterns as applicable to the standard.

DPO Models Requires Option MTH

MSO Models Standard

Bus triggers maximum toggle rate I²C, SPI, RS-232/422/485/UART: 10 Mb/s

USB: low-speed, full-speed

CAN: 1 Mb/s LIN: 100 kb/s

MIL-STD-1553B: 2 Mb/s

Logic pattern trigger (MSO

Models)

Threshold range P6780: -2 to +4.5 V

P6717A/P6750: -1.5 to +4 V

Threshold accuracy ±100 mV + 3% of threshold setting

Enhanced triggering Enhanced triggering corrects the difference in timing between the trigger path and the acquired data path (supports all Pinpoint

trigger types on both A- and B-Events except pattern trigger); Default On (user-selectable); Not available in FastAcq mode.

Trigger on power line signal. Level fixed at 0 V. Line trigger

Digital and Mixed Signal Oscilloscopes – MSO/DPO70000 Series

Pinpoint® trigger system

Visual Trigger Requires Option VET

Max number of areas

Area shapes Rectangle, Triangle, Trapezoid, Hexagon, user defined shapes (can have >40 vertices) Compatibility Visual Trigger qualification is compatible with all trigger types and all trigger sequences

Datasheet

Pinpoint® trigger system

Trigger Types

Trigger	Analog Channels	MSO Logic Channels	Description
Comm ²	X		Support for AMI, HDB3, BnZS, CMI, MLT3, and NRZ encoded signals.
Bus	Х	X	Trigger on a parallel or serial bus when the specific bus value is found.
I ² C ²	X	Х	Trigger on Start, Repeated Start, Stop, Missing ACK, Address (7 or 10 bit), Data, or Address and Data.
SPI ²	X	Х	Trigger on SS or data.
CAN ³	Х	X	Trigger on Start of Frame, Frame Type, Identifier, Data, End of Frame, Missing Ack, Bit Stuff Error.
LIN ³	Х	X	Trigger on Sync, Identifier, Data, Ident and Data, Wakeup Frame, Sleep Frame, Error.
FlexRay ³	X	Х	Trigger on Start of Frame, Indicator Bits, Cycle Count, Header Fields, Identifier, Data, End of Frame, Error.
RS-232/422/485/UART ³	X	X	Trigger on Start Bit, End of Packet, Data, and Parity Error.
USB ³	Х	X	Low-speed or Full-speed: Trigger on Sync, Reset, Suspend, Resume, End of Packet, Token (Address) Packet, Data Packet, Handshake Packet, Special Packet, Error.
MIL-STD-1553B ³	Х	X	Trigger on Sync, Command Word, Status Word, Data, RT/IMG Time, Error.
PCI Express ³	X	X	Trigger on Patterns (including ordered sets), Character/Symbol, Error, Control Characters (gen 1 and gen 2 rates only)
Edge	X	Х	Positive or negative slope on any channel or front-panel auxiliary input. Coupling includes DC, AC, noise reject, HF reject, and LF reject.
B Event Scan	X		B Event Scan is an A to B trigger sequence that will trigger and capture burst event data of interest as defined in the B Event Scan setup menu. Captured bits can be scanned in a sequential or randomized fashion, and alternatively the trigger can toggle between two successive B trigger events. Eye diagrams can be constructed with burst data acquired as a result of scanning B Event.
Glitch	X	Х	Trigger on or reject glitches of positive, negative, or either polarity. Minimum glitch width is 150 ps (typical) with rearm time of 300 ps.
Pattern	X	X	Trigger when pattern goes false or stays true for specified period of time. Pattern (AND, OR, NAND, NOR) specified for four input channels (and 16 logic channels on the MSO70000 Series) defined as high, low, or don't care.
Runt	Х		Trigger on a pulse that crosses one threshold but fails to cross a second threshold before crossing the first again. Event can be time- or logic-qualified.

² Included on MSO models, optional on DPO models

³ Optional on all models

Pinpoint® trigger system

Trigger	Analog Channels	MSO Logic Channels	Description
Serial Pattern ²	X		Trigger on NRZ-encoded data up to 6.25 Gbaud; above 1.25 Gbaud requires 8b/10b encoded data. Includes pattern lock triggering to capture repeated acquisitions of long serial test patterns up to 6.25 Gb/s.
Setup/Hold	X		Trigger on violations of both setup time and hold time between clock and data present on any two input channels.
State	X	X	Any logical pattern of channels (1, 2, 3) (and 16 logic channels on the MSO70000 Series) clocked by edge on channel 4. Trigger on rising or falling clock edge.
Timeout	X	Х	Trigger on an event which remains high, low, or either, for a specified time period. Selectable from 300 ps.
Transition	X		Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative, or either.
Trigger Delay by Events	Х	Х	1 to 2 billion events.
Trigger Delay by Time	Х	Х	3.2 ns to 3 million seconds.
Visual Trigger ³	X		Trigger when the Visual Trigger expression is satisfied.
Width	X	Х	Trigger on width of positive or negative pulse either within or out of selectable time limits (down to 150 ps).
Window	X		Trigger on an event that enters or exits a window defined by two user-adjustable thresholds. Event can be time or logic qualified.

Waveform analysis

Search and Mark Events

Search for edges, glitches, or pulses of specified width. Any events found matching the search criteria are marked and placed in the Event table. The search can use positive/negative slopes or both on any channels.

When an event of interest is found, other similar events can be found using "Mark All Trigger Events in Record" in the Pinpoint trigger control windows.

The Event table summarizes all found events. All events are time stamped in reference to trigger position. Users can choose to stop acquisitions when an event is found.

Waveform measurements	
Automatic measurements	53, of which 8 can be displayed on-screen at any one time; measurement statistics, user-definable reference levels, measurement within gates isolating the specific occurrence within an acquisition to measure
	The DPOJET Jitter and Eye Analysis application offers additional automated and advanced measurements such as jitter.
Amplitude related	Amplitude, High, Low, Maximum, Minimum, Peak-to-Peak, Mean, Cycle Mean, RMS, Cycle RMS, Positive Overshoot, Negative Overshoot
Time related	Rise Time, Fall Time, Positive Width, Negative Width, Positive Duty Cycle, Negative Duty Cycle, Period, Frequency, Delay
Combination	Area, Cycle Area, Phase, Burst Width
Histogram related	Waveform Count, Hits in Box, Peak Hits, Median, Maximum, Minimum, Peak-to-Peak, Mean (µ), Standard Deviation (sigma),

 μ +1sigma, μ +2sigma, μ +3sigma

Waveform analysis

Bus decoding

Parallel Data from selected channels is grouped as a parallel, multichannel bus and displayed as a single bus value. Display can be binary,

hexadecimal, or symbolic formats

I²C² SCLK and SDA channels are displayed as a bus per the Inter-Integrated Circuit specification

SPI² MOSI, MISO, SCLK, and SS channels are displayed as a bus per the Serial Peripheral Interface specification

CAN³ CAN_H, CAN_L, TX, or RX channels are displayed as a bus

LIN³ Data is displayed as a bus in accordance with the LIN Version 1 or Version 2 standards

FlexRay 3 BP, BM, TX, or RX signals are displayed as a bus

HSIC³ Data is displayed as a bus according to the USB2.0 HSIC standard

RS-232/422/485/UART 3 Channel is displayed as a bus

USB³ Channels are displayed as a bus per the USB specification

MIL-STD-1553B 3 Data is displayed as a bus

PCI Express 3 Gen 1, 2, or 3 data rates are automatically detected and displayed as a bus in accordance with the PCIe standard

MIPI® D-PHY 3 DSI or CSI2 channels are displayed as a bus per the MIPI standard

8b/10b Encoded ² Control and data characters are displayed as a bus

Waveform processing/math

Define extensive algebraic expressions including Waveforms, Scalars, User-adjustable Variables, and Results of Parametric Algebraic expressions

Measurements e.g. (Integral (CH1 - Mean(CH1)) × 1.414 × VAR1)

Arithmetic Add, Subtract, Multiply, Divide Waveforms and Scalars

Filtering function User-definable filters. Users specify a file containing the coefficients of the filter. Several example filter files are provided

Frequency domain functions Spectral Magnitude and Phase, Real and Imaginary Spectra

Mask function Generates a Waveform Database pixel map from a sample waveform. Sample count can be defined

Math functions Average, Invert, Integrate, Differentiate, Square Root, Exponential, Log 10, Log e, Abs, Ceiling, Floor, Min, Max, Sin, Cos, Tan,

An interface is provided to allow users to create their own custom math functions in MATLAB or Visual Studio

ASin, ACos, ATan, Sinh, Cosh, Tanh

Relational Boolean result of comparison >, <, \geq , \leq , ==, !=

Vertical units Magnitude: Linear, dB, dBm Phase: Degrees, radians, group delay IRE and mV units

Window functions Rectangular, Hamming, Hanning, Kaiser-Bessel, Blackman-Harris, Gaussian, Flattop2, Tek Exponential

Customized Functions using

Math Plug-in Interface

Display system

Color palettes	Normal, Green, Gray, Temperature, Spectral, and User-defined
Format	YT, XY, XYZ
Display resolution	1024 horizontal × 768 vertical pixels (XGA)
Display type	307.3 mm (12.1 in.) liquid-crystal active-matrix color display
Horizontal divisions	10
Vertical divisions	10
Waveform styles	Vectors, Dots, Variable Persistence, Infinite Persistence

Computer system and peripherals

Operating system	Microsoft Windows 10 Enterprise IoT Edition		
CPU	Intel i7-2600 processor, quad core, 3.4 GHz		
System memory	8 GB (16 GB on DX models)		
Solid state drive	Removable, 512 GB capacity		
CD/DVD drive	Front-panel CD-R/W, DVD-R drive		
Mouse	Optical wheel mouse, USB interface		
Keyboard	USB interface		

Input/Output ports

Auxiliary input	Front panel. See trigger specifications
Auxiliary output	Rear panel. BNC connector, 0 to 3 V; default output is A-Event Trigger low true
Probe calibration output	Front panel. BNC connector, ±10 V DC for DC probe calibration (signal available only during probe calibration)
Fast edge output	Front panel. SMA connector provides fast edge signal. 1 kHz ±20%; 810 mV (base to top) ±20% into ≥10 kΩ load; 440 mV ±20% into a 50 Ω load
Recovered clock output	Front panel. SMA connector, \leq 1.25 Gb/s, Output swing \geq 130 mV _{p-p} into 50 Ω at 1.25 Gb/s. Requires Option ST6G or Option MTH to enable on DPO70000 Series, standard on MSO70000 Series
Recovered data output	Front panel. SMA connector, \leq 1.25 Gb/s, Output swing of 1010 repeating pattern 200 mV into 50 Ω at 1.25 Gb/s. Requires Option ST6G or Option MTH to enable on DPO70000 Series, standard on MSO70000 Series
USB interface	Front panel: Two USB 2.0 ports on 23, 25, and 33 GHz models, one on all others. Allows connection of USB keyboard, mouse, or storage device
	Rear panel: Four USB ports, two are USB 3.0. Allows connection of USB keyboard, mouse, or storage devices
LXI web interface (LAN eXtensions for instrumentation)	Class: LXI Class C Version: 1.3
Audio input/output	Rear panel. Miniature phone jacks for stereo microphone input and stereo line output
External time base reference in	Rear panel. BNC connector; allows time base system to phase lock to external 10/100 MHz reference. Optimized (by using a software switch) for either a highly stable clock or tracking mode
GPIB interface	Rear panel. IEEE 488.2 standard
Keyboard port	Rear panel. PS/2 compatible
LAN port	Rear panel. RJ-45 connector, supports 10BASE-T, 100BASE-T, and 1000BASE-T
Mouse port	Rear panel. PS/2 compatible
eSATA port	Rear panel. External SATA interface for eSATA storage devices
Power	100 to 240 V _{RMS} , ±10%, 50/60 Hz; 115 V _{RMS} ±10%, <870 W, 400 Hz; CAT II, <1100 VA typical

Datasheet

Input/Output ports

Video out port

Connect to show the oscilloscope display, including live waveforms on an external monitor or projector. The primary Windows® desktop can also be displayed on an external monitor using these ports.

Alternatively, the ports can be configured to show the secondary Windows® desktop (also called extended desktop or dual-monitor display)

Both VGA and DVI-D connectors.

Serial port

Rear panel. Two DB-9 COM1 ports

Time base reference out

BNC connector; provides TTL-compatible output of internal 10 MHz reference oscillator

Physical characteristics

im			

	mm	in.
Height	298	11.74
Width	451	17.75
Depth	489.97	19.29

Rackmount dimensions

	mm	in.
Height	311	12.25
Width	480.1	18.9
Depth (from rack mounting ear to back of instrument)	546.1	21.5

Weight

	kg	lb.
Net	24	53
Shipping	34	67

Rackmount weight

	kg	lb.
Net	22	59
Kit	2.7	6

Cooling - Required clearance

	mm	in.
Тор	0	0
Bottom	0	0
Left Side	76	3
Right Side	76	3
Front	0	0
Rear	0	0

Environmental

Temperature

5 °C to +45 °C Operating -20 °C to +60 °C Nonoperating

Humidity

8% to 80% relative humidity (RH) at up to 32 °C Above +32 °C up to +45 °C; as limited by a 29.4 °C wet bulb temperature Operating

5% to 95% relative humidity (RH) Above +32 °C up to +60 °C; as limited by a 29.4 °C wet bulb temperature Nonoperating

Altitude

Operating 3,000 m (9,843 ft.) Nonoperating 12,000 m (39,370 ft.)

Regulatory

Electromagnetic compatibility 2004/108/EC; EN 61326-2-1:2006

Certifications UL 61010-1, CSA 61010-1-04, LVD 2006/95/EC, EN61010-1, IEC 61010-1

Ordering information

MSO/DPO70000 models

MSO70404C 4 GHz Mixed Signal Oscilloscope MSO70604C 6 GHz Mixed Signal Oscilloscope MSO70804C 8 GHz Mixed Signal Oscilloscope MSO71254C 12.5 GHz Mixed Signal Oscilloscope MSO71604C 16 GHz Mixed Signal Oscilloscope MSO72004C 20 GHz Mixed Signal Oscilloscope MSO72304DX 23 GHz Mixed Signal Oscilloscope MSO72504DX 25 GHz Mixed Signal Oscilloscope MSO73304DX 33 GHz Mixed Signal Oscilloscope DPO70404C 4 GHz Digital Phosphor Oscilloscope DPO70604C 6 GHz Digital Phosphor Oscilloscope DPO70804C 8 GHz Digital Phosphor Oscilloscope DPO71254C 12.5 GHz Digital Phosphor Oscilloscope 16 GHz Digital Phosphor Oscilloscope DPO71604C DPO72004C 20 GHz Digital Phosphor Oscilloscope DPO72304DX 23 GHz Digital Phosphor Oscilloscope DPO72504DX 25 GHz Digital Phosphor Oscilloscope DPO73304DX 33 GHz Digital Phosphor Oscilloscope

Standard accessories

Accessories

071-2980-xx User Manual (please specify language when ordering)

TCA-292MM (4 included) TekConnect® to 2.92 mm Adapter (C models) TekConnect® to 2.92 mm Adapter (DX models) TCA-292D (4 included)

TCA-BNC TekConnect® to BNC Adapter

Accessory Pouch Front Cover Mouse

Power Cord (please specify power plug option when ordering)

Static Protection Wrist Strap

GPIB Programmer's Reference (on product SSD)

Keyboard

Performance Verification Procedure PDF File

Calibration Certificate Documenting NIST Traceability

Z 540-1 Compliance and ISO9001

P6717A General Purpose Logic Probe (MSO models)

Logic Probe Deskew Fixture (MSO models)

Instrument options

Record length options

Option	Description
Opt. 5XL	Extended record length - 62.5 M/Ch
Opt. 10XL	Extended record length - 125M/Ch
Opt. 20XL	Extended record length - 250M/Ch
Opt. 50XL	Extended record length - 500M/Ch
Opt. 510XL	Extended record length - 125M/Ch for DPO units w/ option DSA
Opt. 520XL	Extended record length - 250M/Ch for DPO units w/ option DSA
Opt. 550XL	Extended record length - 500M/Ch for DPO DX units w/ option DSA

Storage options

Option	Description
Opt. SSD	Solid State Drive assembly additional customer-installable removable drive with Microsoft Windows
	10 OS, TekScope and applications software installed

Trigger and search options

Option	Description
Opt. LT	Waveform Limit Testing
Opt. MTH	Mask Testing, Includes Hardware Clock Recovery
Opt. ST6G	8b/10b Serial Protocol Trigger and Decode up to 6.25Gb/s

Advanced analysis options

Option	Description
Opt. BRR	BroadR-Reach/100BASE-T1 and 1000BASE-T1 Automated Compliance Solution
Opt. C-PHY	Manual C-PHY Essentials Transmitter Solution
Opt. DDRA	DDR Memory Bus Analysis (Requires DJA)
Opt. DDR-LP4	LPDDR4 Memory Bus Electrical Validation and Analysis Oscilloscope Software
Opt. DJA	Jitter and Eye Analysis Tools - Advanced (DPOJET)
Opt. DJAN	DPOJET NOISE, JITTER AND EYE ANALYSIS TOOLS
Opt. DP12	DisplayPort 1.2 Source Test Automation Software
Opt. DP14	DisplayPort 1.4 Source Test Automation Software
Opt. D-PHY	MIPI D-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires DJA)
Opt. DSA	Digital Serial Analysis Bundle (includes 5XL, DJA, MTH, ST6G)
Opt. EDP	Embedded DisplayPort 1.3 Essentials
Opt. EDP14	Embedded Display Port 1.4 Essentials
Opt. ERRDT	Frame and Bit Error Rate Detector for High Speed Serial Stds (requires ST6G)
Opt. ET3	Ethernet Compliance Testing
Opt. FC-16G	Fiber Channel - 16G DPOJET Essentials
Opt. HDM	HDMI 2.0 Advanced Analysis and Compliance Software for Tx tests
Opt. HDM-DS	HDMI 2.0 Advanced Analysis and Compliance Software for Rx tests Upgrade Option Software for Tx tests
Opt. HDM-DSM	HDMI 2.0 Advanced Analysis and Characterization Software for Rx tests
Opt. HSIC	HSIC Essentials - Electrical Validation and Protocol Decode Solution (Optionally Requires DJA for measurements)
Opt. HT3	HDMI Compliance Testing
Opt. HT3DS	HDMI Direct Synthesis for HDMI 1.4 (Requires HT3)
Opt. MHD	MHL Advanced Analysis and Compliance Software (Requires DJA and 2XL on DPO models)
Opt. MHD3	MHL 3.0 Advanced Analysis and Compliance Software for Tx, Rx, Dongle and Cable tests (requires Opt MHD)
Opt. MOST	MOST Essentials- Electrical Compliance and Debug Test Solution for MOST50 and MOST150 (Requires DJA)
Opt. M-PHY	MIPI® M-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires DJA)
Opt. M-PHYTX	M-PHY Automated Transmitter Solution
Opt. M-PHYRX	M-PHY Automated Receiver Solution
Opt. NBASET	NBASE-T TekExpress Conformance and Debug Solution
Opt. PAM4	PAM4 Transmitter Analysis Software
Opt. PCE	PCI Express® Gen1/2 DPOJet Measurements Software Only [no TekExpress] (Requires Opt DJA)
Opt. PCE3	PCI Express® Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJet Measurements Software (Requires Opt DJA)
Opt. PCE4	PCI Express® Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJet and SigTest Measurements Software, Gen 4 Debug with DPOJET Measurement Library (Requires Opt DJA and Opt SDLA64)
Opt. PWR	Power Measurement and Analysis
Opt. QPI	QPI 1.1 Test Automation Software
Opt. SC	SignalCorrect Cable and Channel Compensation Software
Opt. SDLA64	Serial Data Link Analysis Visualizer
Opt. SFP-TX	SFP+ Compliance and Debug Solution (Requires Opt. DJA)
Opt. SFP-WDP	SFP+ Compliance and Debug Solution – WDP Measurement (Requires Opt. DJA)
Opt. SR-810B	8b/10b Serial Analysis
Opt. SR-AERO	Aerospace Serial Triggering and Analysis (MIL-STD-1553B)

Det. SR-COMP Computer Serial Triggering and Analysis (RS-232/422/485/UART) Det. SR-CUST Custom Serial Analysis Kit for Developers Det. SR-DPHY MIPI® D-PHY (DSI / CSI2) Serial Analysis Det. SR-EMBD Embedded Serial Triggering and Analysis (I²C, SPI) Det. SR-ENET Ethernet Serial Analysis (10BASE-T and 100BASE-TX) Det. SR-PCIE PCI Express Serial Analysis Det. SR-USB USB Serial Triggering and Analysis Det. SR-USB USB Serial Triggering and Analysis Det. SSIC SIC Protocol Decoder Det. SVA AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Det. SVE SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes Det. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Det. SVO Flexible OFDM Analysis (Requires Opt. SVE) Det. SVP Advanced Signal Analysis (Including pulse measurements) (Requires Opt. SVE) Det. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Det. SV23 WLAN 802.11ar by gify measurements (Requires Opt. SVE) Det. SV24 WLAN 802.11ar measurement application (Requires Opt. SV23) Det. SV25 WLAN 802.11ar measurement application (Requires Opt. SV24) APCO P25 measurement application (Requires Opt. SVE) Det. SV26 APCO P25 measurement application (Requires Opt. SVE) Det. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Det. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Det. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Det. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Det. SW3-DP Switch Matrix option for DisplayPort testing Det. SW7-DP Visual Trigger and Search	Option	Description
Opt. SV2 Opt. SV3 Opt. SV3 Opt. SV3 Opt. SV3 Opt. SV3 Opt. SV3 Opt. SV4 Opt. SV4 Opt. SV6 Opt. SV6 Opt. SV6 Opt. SV7 Opt. SV8 Opt	Opt. SR-AUTO	Automotive Serial Triggering and Analysis (CAN/LIN/FlexRay)
Det. SR-DPHY MIPI® D-PHY (DSI / CSI2) Serial Analysis Det. SR-EMBD Embedded Serial Triggering and Analysis (I ² C, SPI) Det. SR-ENET Ethernet Serial Analysis (10BASE-T and 100BASE-TX) Det. SR-PCIE PCI Express Serial Analysis Det. SR-USB USB Serial Triggering and Analysis Det. SR-USB USB Serial Triggering and Analysis Det. SSIC SIC Protocol Decoder Det. SVA AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Det. SVE SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes Det. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Det. SVO Flexible OFDM Analysis (Requires Opt. SVE) Det. SVO Flexible OFDM Analysis (including pulse measurements) (Requires Opt. SVE) Det. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Det. SV23 WLAN 802.11a/b/g//p measurements (Requires Opt. SVE) Det. SV24 WLAN 802.11a measurement application (Requires Opt. SV23) Det. SV24 WLAN 802.11a measurement application (Requires Opt. SV24) Det. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Det. SV26 APCO P25 measurement application Det. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Det. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Det. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Det. SWX-DP Switch Matrix option for DisplayPort testing Det. TBT-TX Thunderbolt TX Compliance Test Application Det. VET Visual Trigger and Search Det. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SR-COMP	Computer Serial Triggering and Analysis (RS-232/422/485/UART)
Det. SR-EMBD Embedded Serial Triggering and Analysis (I²C, SPI) Det. SR-ENET Ethernet Serial Analysis (10BASE-T and 100BASE-TX) Det. SR-PCIE PCI Express Serial Analysis Det. SR-USB USB Serial Triggering and Analysis Det. SVA AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Det. SVE SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes Det. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Det. SVO Flexible OFDM Analysis (Requires Opt. SVE) Det. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Det. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Det. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Det. SV24 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Det. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Det. SV26 APCO P25 measurement application (Requires Opt. SV24) Det. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Det. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Det. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Det. SWX-DP Switch Matrix option for DisplayPort testing Det. TBT-TX Thunderbolt TX Compliance Test Application Det. VET Visual Trigger and Search Det. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SR-CUST	Custom Serial Analysis Kit for Developers
Dyt. SR-ENET Ethemet Serial Analysis (10BASE-T and 100BASE-TX) Dyt. SR-PCIE PCI Express Serial Analysis Dyt. SR-USB USB Serial Triggering and Analysis Dyt. SSIC SIC Protocol Decoder Dyt. SVA AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Dyt. SVE SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes Dyt. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Dyt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Dyt. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Dyt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Dyt. SV23 WLAN 802.11a/b/g/i/p measurements (Requires Opt. SVE) Dyt. SV24 WLAN 802.11a/b/g/i/p measurement application (Requires Opt. SV23) Dyt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Dyt. SV26 APCO P25 measurement application (Requires Opt. SVE) Dyt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Dyt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Dyt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Dyt. SWX-DP Switch Matrix option for DisplayPort testing Dyt. TBT-TX Thunderbolt TX Compliance Test Application Dyt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SR-DPHY	MIPI® D-PHY (DSI / CSI2) Serial Analysis
Dyt. SR-PCIE PCI Express Serial Analysis Dyt. SRIC Dyt. SSIC SSIC Protocol Decoder Dyt. SVA AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Dyt. SVE SignalVu® Essentials – Vector Signal Analysis (Requires Opt. SVE) Dyt. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Dyt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Dyt. SVV Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Dyt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Dyt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Dyt. SV24 WLAN 802.11ar measurement application (Requires Opt. SV23) Dyt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Dyt. SV26 APCO P25 measurement application Dyt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Dyt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Dyt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Dyt. SWX-DP Switch Matrix option for DisplayPort testing Thunderbolt TX Compliance Test Application Dyt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SR-EMBD	Embedded Serial Triggering and Analysis (I ² C, SPI)
Dyt. SR-USB USB Serial Triggering and Analysis SSIC Protocol Decoder AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Opt. SVE SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes Opt. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Opt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Opt. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Opt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Opt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Opt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Opt. SV26 APCO P25 measurement application Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Switch Matrix option for DisplayPort testing Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SR-ENET	Ethernet Serial Analysis (10BASE-T and 100BASE-TX)
Dipt. SSIC SSIC Protocol Decoder Dipt. SVA AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Dipt. SVE SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes Dipt. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Dipt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Dipt. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Dipt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Dipt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Dipt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Dipt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Dipt. SV26 APCO P25 measurement application Dipt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Dipt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Dipt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Dipt. SWX-DP Switch Matrix option for DisplayPort testing Dipt. TBT-TX Thunderbolt TX Compliance Test Application Dipt. VET Visual Trigger and Search Dipt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SR-PCIE	PCI Express Serial Analysis
AM/FM/PM Audio Signal Analysis (Requires Opt. SVE) Opt. SVE SignalVu® Essentials – Vector Signal Analysis (Sequires Opt. SVE) Opt. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Opt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Opt. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Opt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Opt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Opt. SV24 WLAN 802.11a measurement application (Requires Opt. SV23) Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Opt. SV26 APCO P25 measurement application (Requires Opt. SVE) Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SR-USB	USB Serial Triggering and Analysis
Dipt. SVE SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes Dipt. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Dipt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Dipt. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Dipt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Dipt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Dipt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Dipt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Dipt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Dipt. SV26 APCO P25 measurement application Dipt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Dipt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Dipt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Dipt. SWX-DP Switch Matrix option for DisplayPort testing Dipt. TBT-TX Thunderbolt TX Compliance Test Application Dipt. VET Visual Trigger and Search Dipt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SSIC	SSIC Protocol Decoder
Opt. SVM General Purpose Digital Modulation Analysis (Requires Opt. SVE) Opt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Opt. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Opt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Opt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Opt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Opt. SV26 APCO P25 measurement application Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search Opt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SVA	AM/FM/PM Audio Signal Analysis (Requires Opt. SVE)
Dpt. SVO Flexible OFDM Analysis (Requires Opt. SVE) Dpt. SVP Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Dpt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Dpt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Dpt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Dpt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Dpt. SV26 APCO P25 measurement application Dpt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Dpt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Dpt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Dpt. SWX-DP Switch Matrix option for DisplayPort testing Dpt. TBT-TX Thunderbolt TX Compliance Test Application Dpt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SVE	SignalVu® Essentials – Vector Signal Analysis Software for oscilloscopes
Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE) Opt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Opt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Opt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Opt. SV26 APCO P25 measurement application Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SVM	General Purpose Digital Modulation Analysis (Requires Opt. SVE)
Opt. SVT Settling Time, Frequency, and Phase (Requires Opt. SVE) Opt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Opt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Opt. SV26 APCO P25 measurement application Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SVO	Flexible OFDM Analysis (Requires Opt. SVE)
Opt. SV23 WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE) Opt. SV24 WLAN 802.11n measurement application (Requires Opt. SV23) Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) Opt. SV26 APCO P25 measurement application Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search Opt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SVP	Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE)
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Opt. SV25 WLAN 802.11ac measurement application (Requires Opt. SV24) APCO P25 measurement application Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SV23	WLAN 802.11a/b/g/j/p measurements (Requires Opt. SVE)
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Opt. SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE) Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SV25	WLAN 802.11ac measurement application (Requires Opt. SV24)
Opt. SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) Dpt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Dpt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search Dpt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SV26	APCO P25 measurement application
Opt. SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE) Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search Opt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SV27	SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE)
Opt. SWX-DP Switch Matrix option for DisplayPort testing Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search Opt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SV28	SignalVu LTE DownLink RF measurements (Requires Opt. SVE)
Opt. TBT-TX Thunderbolt TX Compliance Test Application Opt. VET Visual Trigger and Search Opt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SV30	IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE)
Opt. VET Visual Trigger and Search Opt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. SWX-DP	Switch Matrix option for DisplayPort testing
Opt. 100G-TXE IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance. Requires DJA or	Opt. TBT-TX	Thunderbolt TX Compliance Test Application
	Opt. VET	Visual Trigger and Search
	Opt. 100G-TXE	
Opt. 10G-KR 10GBASE-KR/KR4 Compliance and Debug Solution	Opt. 10G-KR	10GBASE-KR/KR4 Compliance and Debug Solution
Opt. 400G-TXE IEEE-802.3bs/cd: 50-400GAUI, 50-200G-KR, 50-200G-CR, OIF-CEI (VSR, MR, LR) Electrical Transmitter Compliance. Requires DJA, DJAN, PAM4, SDLA64.	Opt. 400G-TXE	
Opt. 40G-CR4 40GBASE-CR4 Debug and Automated Compliance Solution	Opt. 40G-CR4	40GBASE-CR4 Debug and Automated Compliance Solution

Floating license options

Floating licenses offer an alternative method to manage your Tektronix asset. Floating licenses allow license-key enabled options to be easily moved among all your MSO/DPO70000, DPO70000, and MSO/DPO5000 Series oscilloscopes. Floating licenses are available for the license-key enabled options listed below.

Check www.tek.com/products/oscilloscopes/floating-licenses for additional information about floating license options.

Option	Description
DPOFL-10G-KR	License, floating; 10GBASE-KR/KR4 Compliance and Debug Solution (requires Option DJA and Option SR-CUST; for models of bandwidth ≥16 GHz only)
DPOFL-100G-TXE	License, floating; IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100 Gbps Transmitter Compliance (requires Option DJA)
DPOFL-40G-CR4	License, floating; 40GBASE-CR4 Debug and Automated Compliance Solution
DPOFL-400G-TXE	License, floating; 400G Electrical Transmitter Compliance (requires Options DJA, DJAN, PAM4, and SDLA64)
DPOFL-BRR	License, floating; BroadR-Reach/100BASE-T1 and 1000BASE-T1 Automated Compliance Solution
DPOFL-C-PHY	License, floating; MIPI® C-PHY Essentials Transmitter Solution (requires Option DJA)
DPOFL-C-PHYTX	License, floating; MIPI® C-PHY TekExpress 3.0 Automation Software for Transmitter (requires Option DJA)
DPOFL-D-PHY	License, floating; MIPI® D-PHY Transmitter Debug, Characterization and Compliance Test Solution (requires Option DJA)
DPOFL-DDR-LP4	License, floating; LPDDR4 Memory Bus Electrical Validation and Analysis Oscilloscope Software
DPOFL-DDRA	License, floating; DDR Memory Technology Analysis Package (requires Option DJA)
DPOFL-DJA	License, floating; Advanced Jitter Analysis for use with TekScope Anywhere; DPO/DSA/MSO70000C/D/DX; DPO7000C or DPO/MSO5000 Oscilloscopes (DPOJET)
DPOFL-DJAN	License, floating; DPOJET Noise, Jitter and Eye Analysis Tools
DPOFL-DP12	License, floating; DisplayPort 1.2 Test Automation Software
DPOFL-DP14	License, floating; DisplayPort 1.4 Source Test Automation Software
DPOFL-DSA	License, floating; MSO Digital Serial Analysis Bundle
DPOFL-DSPT	License, floating; DisplayPort Transmitter Compliance Test Software
DPOFL-EDP	License, floating; Embedded Display Port Essentials
DPOFL-EDP14	License, floating; Embedded Display Port 1.4 Essentials
DPOFL-ERRDT	License, floating; Frame and Bit Error Rate Detector for High-speed Serial Standards (requires Option ST6G)
DPOFL-ET3	License, floating; Ethernet Compliance Testing (requires Ethernet Test Fixture)
DPOFL-FC-16G	License, floating; Fiber Channel - 16G DPOJET Essentials
DPOFL-HDM	License, floating; Advanced Analysis and Compliance Software for HDMI 2.0 TX
DPOFL-HDM-DS	License, floating; Advanced Analysis and Compliance Software for HDMI 2.0 RX
DPOFL-HDM-DSM	License, floating; HDMI 2.0 Advanced Analysis and Characterization Software for RX Tests
DPOFL-HSIC	License, floating; HSIC Essentials - Electrical Validation and Protocol Decode Solution (optionally requires Option DJA for measurements)
DPOFL-HT3	License, floating; Floating license; HDMI Compliance Testing
DPOFL-HT3DS	License, floating; HDMI Direct Synthesis for HDMI 1.4 (requires Option HT3)
DPOFL-LT	License, floating; Waveform Limit Testing
DPOFL-M-PHY	License, floating; MIPI® M-PHY Essentials
DPOFL-M-PHYRX	License, floating; M-PHY Automated Receiver Solution (requires Option ST6G and Option ERRDT)
DPOFL-M-PHYTX	License, floating; M-PHY Automated Transmitter Solution (requires Option DJA)
DPOFL-MHD	License, floating; Advanced Analysis and Compliance software for MHL
DPOFL-MOST	License, floating; MOST Essentials (requires Option DJA)
DPOFL-MTH	License, floating; Mask Testing with Hardware Clock Recovery
DPOFL-MTM	License, floating; Communication Mask Testing

Option	Description
DPOFL-NBASET	License, floating; TekExpress Automated NBASET Solution
DPOFL-PAM4	License, floating; PAM4 Transmitter Analysis Software
DPOFL-PCE	License, floating; PCI Express® Gen1/2 DPOJET Measurements Software Only - no TekExpress (requires Option DJA)
DPOFL-PCE3	License, floating; PCI Express® Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJET Measurements Software (requires Option DJA; for models of bandwidth ≥6 GHz only)
DPOFL-PCE4	License, floating; PCI Express® Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJET and SigTest Measurements Software, Gen 4 Debug with DPOJET Measurement Library (requires Option DJA and Option SDLA64)
DPOFL-PTD	License, floating; Serial Protocol Trigger and Decode
DPOFL-PWR	License, floating; Power Measurement and Analysis Software
DPOFL-SAS3	License, floating; SAS-3 TX Compliance Test Application (requires Option DJA and Option 2XL or higher, for models of bandwidth ≥20 GHz only)
DPOFL-SAS3-TSG	License, floating; SAS-3 Automated TX Compliance Test Application
DPOFL-SAS3-TSGW	License, floating; SAS-3 WDP Transmitter Measurements
DPOFL-SATA-DHB	License, floating; SATA TSG/RSG Bundle for TekExpress
DPOFL-SATA-RSG	License, floating; SATA RSG/RMT Receiver Tests for TekExpress
DPOFL-SATA-TSG	License, floating; SATA PHY/TSG/OOB Transmitter Tests for TekExpress
DPOFL-SC	License, floating; SignalCorrect Cable, Channel, and Probe Compensation Software
DPOFL-SDLA64	License, floating; Serial Data Link Analysis
DPOFL-SFP-TX	License, floating; Ethernet SFP+/QSFP+ Compliance and Debug Solution (requires Option DJA)
DPOFL-SFP-WDP	License, floating; Ethernet SFP+/QSFP+ Compliance and Debug Solution (requires Option DJA)
DPOFL-SR-810B	License, floating; 8b/10b Serial Analysis
DPOFL-SR-AERO	License, floating; Aerospace Serial Triggering and Analysis (MIL-STD-1553B)
DPOFL-SR-AUTO	License, floating; Automotive Serial Triggering and Analysis (CAN/LIN/FlexRay)
DPOFL-SR-COMP	License, floating; Computer Serial Triggering and Analysis (RS-232/422/485/UART)
DPOFL-SR-DPHY	License, floating; MIPI® D-PHY (DSI / CSI2) Serial Analysis
DPOFL-SR-EMBD	License, floating; Embedded Serial Triggering and Analysis (I ² C, SPI)
DPOFL-SR-ENET	License, floating; Ethernet Serial Analysis (10BASE-T and 100BASE-TX)
DPOFL-SR-PCIE	License, floating; PCI Express Serial Analysis (requires Option ST6G for triggering)
DPOFL-SR-USB	License, floating; USB Serial Triggering and Analysis
DPOFL-SSIC	License, floating; SSIC Protocol Decoder
DPOFL-ST6G	License, floating; 8b/10b Serial Protocol Trigger and Decode up to 6.25 Gb/s
DPOFL-STU	License, floating; Upgrade from 3.125 Gb/s to 6.25 Gb/s 8b/10b Serial Protocol Trigger and Decode
DPOFL-SV23	License, floating; WLAN 802.11a/b/g Measurements (requires Option SVE)
DPOFL-SV24	License, floating; WLAN 802.11n Measurements (requires Option SV23)
DPOFL-SV25	License, floating; WLAN 802.11ac Measurements (requires Option SV24, for models of bandwidth ≥6 GHz only)
DPOFL-SV26	License, floating; APCO P25 Measurement Application (requires Option SVE)
DPOFL-SV27	License, floating; SignalVu Bluetooth Basic LE TX SIG Measurements (requires Option SVE)
DPOFL-SV28	License, floating; SignalVu LTE Downlink RF Measurements (requires Option SVE)
DPOFL-SVA	License, floating; AM/FM/PM/Direct Audio Analysis (requires Option SVE)
DPOFL-SVE	License, floating; SignalVu® Essentials – Vector Signal Analysis Software
DPOFL-SVM	License, floating; SignalVu® General Purpose Modulation Analysis (requires Option SVE)
DPOFL-SVO	License, floating; Flexible OFDM Analysis (requires Option SVE)
DPOFL-SVP	License, floating; SignalVu® Pulse Measurements (requires Option SVE)

Option	Description
DPOFL-SVT	License, floating; Frequency and Phase Settling Time Measurements (requires Option SVE)
DPOFL-TBT-TX	License, floating; Thunderbolt Transmitter Characterization, Debug, and Compliance Testing (requires Option DJA and Option 2XL or higher, for models of bandwidth ≥16 GHz only)
DPOFL-UHS-2	License, floating; UHS-2 - UHS-II Automated Compliance and Margin Test Solution for Host and Device - transmitter and receiver (for models of bandwidth ≥6 GHz only)
DPOFL-USB-TX	License, floating; USB 3.0 Automated TX Compliance Test Application (requires Option DJA, for models of bandwidth ≥8 GHz only)
DPOFL-USB-TX-UP	Floating License Upgrade from TEKEXP USB-TX (dongle-based licensing) to DPOFL-USB-TX
DPOFL-USB2	License, floating; USB 2.0 Automated Compliance Test Application
DPOFL-USBPWR	License, floating; USB Power Adapter/EPS Compliance Automated Test Solution (not supported on 70000D models)
DPOFL-USBSSP-TX	License, floating; USB 3.1 Automated TX Compliance Test Application
DPOFL-USBSSP-UP	Floating License Upgrade from Floating USB TX to Floating USB SSP TX
DPOFL-VET	License, floating; Visual Trigger
DPOFL-XGBT2	License, floating; TekExpress Automated 10GBASE-T Solution
DPOFL-XL02	License, floating; Extended record length – 31.25 M Samples/Ch
DPOFL-XL05	License, floating; Extended record length – 62.5 M Samples/Ch
DPOFL-XL010	License, floating; Extended record length – 125 M Samples/Ch
DPOFL-XL020	License, floating; Extended record length – 250 M Samples/Ch (for models of bandwidth ≥12.5 GHz only)
DPOFL-XL050	License, floating; Extended record length - 500 M Samples each Ch, 1 G Samples on 2 Ch (DX models only)

TekExpress application framework options

Option	Description
TEKEXP	TekExpress® Automation Framework
Opt. D-PHYTX	D-PHY Automated Solution
Opt. DIIVA	DiiVA Automation Solution
Opt. DP-SINK	DisplayPort Sink Compliance Automation Software
Opt. HEAC	HEAC Automated Solution
Opt. SAS3	SAS-3 TX Compliance Test Application
Opt. SAS3-TSG	SAS-3 Automated Tx Compliance Test Application
Opt. SAS3-TSGW	SAS Transmitter Measurements includes a licensed set of WDP measurements
Opt. SATA-DHB	SATA TekExpress SATA SW Bundle (TSG and RSG for Hosts or Devices)
Opt. SATA-TSG	SATA PHY/TSG/OOB Transmitter Tests for TekExpress®
Opt. SATA-RSG	SATA RSG/RMT Receiver Tests for TekExpress®
Opt. SFP-TX	Ethernet SFP+/QSFP+ Compliance and Debug Solution
Opt. SFP-WDP	Ethernet SFP+/QSFP+ Compliance and Debug Solution
Opt. USB2	USB 2.0 Automated Compliance Test Application
Opt. USBPWR	USB Power Adapter/ EPS Compliance Automated Test Solution
Opt. USBSSP-TX	USB 3.1 Automated TX Compliance Test Application
Opt. USB-TX	TekExpress® Automated USB 3.0 Solution
Opt. USB-TX-UP	TEKEXP USB-TX to USB-TX Upgrade
Opt. XGBT2	10GBASE-TekExpress® Conformance and Debug Solution

Upgrade options

The MSO/DPO70000 Series instruments can be easily upgraded after initial time of purchase. To upgrade an existing MSO/DPO70000, order DPO-UP and an option listed below. For example, to add option DDRA, DDR Memory Technology Analysis Package, order DPO-UP DDRA.

Memory upgrades for DPO70000

Series

XL02 From standard record length to Opt. 2XL Configuration XL05 From standard record length to Opt. 5XL Configuration XL010 From standard record length to Opt. 10XL Configuration XL020 From standard record length to Opt. 20XL Configuration

Memory upgrades for MSO/

DPO70000 Series

XL25 From Opt. 2XL record length to Opt. 5XL XL210 From Opt. 2XL record length to Opt. 10XL XL220 From Opt. 2XL record length to Opt. 20XL XL250 From Opt. 2XL record length to Opt. 50XL XL510 From Opt. 5XL record length to Opt. 10XL XL520 From Opt. 5XL record length to Opt. 20XL XL550 From Opt. 5XL record length to Opt. 50XL XL1020 From Opt. 10XL record length to Opt. 20XL XL1050 From Opt. 10XL record length to Opt. 50XL XL2050 From Opt. 20XL record length to Opt. 50XL

Trigger and search upgrades for MSO/DPO70000 Series

> LT Waveform Limit Testing

MTH Mask Testing, Includes Hardware Clock Recovery ST6G 8b/10b Serial Protocol Trigger and Decode up to 6.25Gb/s STU Serial Pattern triggering up to 6.25Gb/s (Requires Opt. PTH)

Advanced analysis upgrades for MSO/DPO70000 Series

> BRR BroadR-Reach/100BASE-T1 and 1000BASE-T1 Automated Compliance Solution

C-PHY Manual C-PHY Essentials Transmitter Solution

D-PHY MIPI® D-PHY ESSENTIALS

DDR-LP4 LPDDR4 Memory Bus Electrical Validation and Analysis Oscilloscope Software (Requires Option DJA, ASM and DDRA)

DDRA DDR Memory Bus Analysis (Requires DJA)

DJAH Jitter and Eye Analysis Tools - Advanced (DPOJET) for 70k Series <12 GHz

DJAN DPOJET Noise and BER Analysis

DJAU Jitter and Eye Analysis Tools - Advanced (DPOJET) for 70k Series >12 GHz

DP12 DisplayPort 1.2 Source Test Automation Software DP14 DisplayPort 1.4 Source Test Automation Software

DSAH Digital Serial Analysis Bundle for 4GHz to 8GHz Models (Includes 5XL, DJA, MTH, ST6G) **DSAU** Digital Serial Analysis Bundle for 12.5GHz to 20GHz Models (Includes 5XL, DJA, MTH, ST6G) **DSAX** Digital Serial Analysis Bundle for DPO70KDX Models (Includes 5XL, DJA, MTH, ST6G)

EDP Embedded Display Port Essentials EDP14 Embedded Display Port 1.4 Essentials

ERRDTH Frame and Bit Error Rate Detector for High Speed Serial Stds for 70k Series <12 GHz (Requires option ST6G) **ERRDTU** Frame and Bit Error Rate Detector for High Speed Serial Stds for 70k Series >12 GHz (Requires option ST6G)

ET3 **Ethernet Compliance Testing**

FC-16G Fiber Channel - 16G DPOJET Essentials

Datasheet

HDD7 Hard Disk Drive for 7000C and 70000C series with at least 500GB (removable, Windows 7 OS, TekScope software and

applications installed.)

HDM HDMI 2.0 Advanced Analysis and Compliance Software for Tx tests
 HDM-DS HDMI 2.0 Advanced Analysis and Compliance Software for Rx tests

HDM-DSM HDMI 2.0 Advanced Analysis and Characterization Software for Rx tests (requires Opt HDM-DS)

HSIC HSIC Essentials - Electrical Validation and Protocol Decode Solution (includes SR-CUST, Optionally requires DJA for

measurements)

HT3 HDMI Compliance Testing

HT3DS HDMI Direct Synthesis for HDMI 1.4

M-PHY MIPI® M-PHY Transmitter Debug, Characterization and Compliance Test Solution (requires DJA)

M-PHYTX M-PHY Automated Transmitter Solution

MBDRAM DRAM update from 4 GB to 8 GB for Advantech AIMB-566 Motherboard

MHD MHL Advanced Analysis and Compliance Software (Requires Opt. DJA and Opt. 2XL)

MHD 3.0 Advanced Analysis and Compliance Software for Tx, Rx, Dongle and Cable tests Upgrade Option (Requires Opt MHD)

MOST Essentials - Electrical Compliance and Debug Test Solution for MOST50 and MOST150 (Requires DJA)

MSOX Adds MSO features to DPO70KDX models

NBASET NBASE-T TekExpress Conformance and Debug Solution

PAM4 Transmitter Analysis Software

PCE PCI Express Gen1/2 DPOJet Measurements Software Only [no TekExpress] (Requires Opt DJA)

PCE3 PCI Express® Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJet Measurements Software (Requires Opt DJA)
PCE4 PCI Express Gen1/2/3/4 TekExpress Compliance/Debug Automation with DPOJet & SigTest Measurements Software (Requires

Opt DJA and Opt SDLA64)

PWR Power Measurement and Analysis

SAS3 Upgrade to SAS-3 TX Compliance Test Application
SAS3-TSG SAS-3 Automated Tx Compliance Test Application

SAS3-TSGW SAS Transmitter Measurements includes a licensed set of WDP measurements

SATA-DHB SATA TSG/RSG Bundle for TekExpress®

SATA-R-UP

TEKEXP Upgrade for SATA RSG/RMT Receiver Tests for TekExpress®

SATA-RSG SATA RSG/RMT Receiver Tests for TekExpress®

SATA-T-UP

TEKEXP Upgrade to SATA PHY/TSG/OOB Transmitter Tests for TekExpress®

SATA-TSG SATA PHY/TSG/OOB Transmitter Tests for TekExpress®
SC SignalCorrect Cable and Channel Compensation Software

SDLA64 Serial Data Link Analysis for Win7 (64 bit) Scopes

SFP-TX Ethernet SFP+/QSFP+ Compliance and Debug Solution

SFP-WDP Ethernet SFP+/QSFP+ Compliance and Debug Solution

SR-810B 8b/10b Serial Analysis

 SR-AERO
 Aerospace Serial Triggering and Analysis (MIL-STD-1553B)

 SR-AUTO
 Automotive Serial Triggering and Analysis (CAN/LIN/FlexRay)

 SR-COMP
 Computer Serial Triggering and Analysis (RS-232/422/485/UART)

SR-DPHY MIPI® D-PHY (DSI / CSI2) Serial Analysis

SR-EMBD Embedded Serial Triggering and Analysis (I²C, SPI)
SR-ENET Ethernet Serial Analysis (10BASE-T and 100BASE-TX)

SR-PCIE PCI Express Serial Analysis
SR-USB USB Serial Triggering and Analysis

SSD Solid State Drive assembly; additional customer-installable removable drive with Microsoft Windows 7 OS, TekScope, and

applications software installed.

SSP USB 3.1 SuperSpeedPlus Transmitter Test Software

Add WLAN 802.11a/b/g/j/p measurements **SV23**

SV24 Add WLAN 802.11n measurements (Requires Opt. SV23) SV25 Add WLAN 802.11ac measurements (Requires Opt. SV24)

SV26 APCO P25 measurement application

SV27 SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE)

SV28 SignalVu LTE DownLink RF measurements (Requires Opt. SVE) SV30 IEEE 802.11AD SC Wideband Waveform Analysis (Requires Opt. SVE)

SVA AM/FM/PM/Direct Audio Analysis (Requires Opt. SVE)

SVEH SignalVu® Essentials - Vector Signal Analysis Software for 70k Series <12 GHz **SVEU** SignalVu® Essentials - Vector Signal Analysis Software for 70k Series >12 GHz

SignalVu General Purpose Modulation Analysis (Requires Opt. SVE)

SVO Flexible OFDM Analysis (Requires Opt. SVE)

SVP SignalVu Pulse Advanced Signal Analysis Software (Requires Opt. SVE) Settling Time Measurements (Frequency and Phase) (Requires Opt. SVE)

SWX-DP Switch Matrix option for DisplayPort testing **SWX-PCE** Switch Matrix for PCIE - Multi Lane Automation

TBT-TX Upgrade to Thunderbolt TX Compliance Test Application

USB-TX TekExpress® Automated USB 3.0 Solution TEKEXP USB-TX to USB-TX Upgrade **USB-TX-UP**

USB₂ USB 2.0 Automated Compliance Test Application

USB3 USB 3.0 Essentials (Requires DJA)

USBPWR USB Power Adapter/ EPS Compliance Automated Test Solution

USBSSP-TX USB 3.1 Automated TX Compliance Test Application

USBSSP-UP USB-TX to USBSSP-TX Upgrade

VETH Visual Trigger and Search for 70K Series <12 GHz **VETU** Visual Trigger and Search for 70K Series >12 GHz

VNM CAN/LIN Protocol Analysis Software

XGBT2 10GBASE-TekExpress Conformance and Debug Solution

100G-TXE Upgrade existing instrument to support IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance.

Requires DJA or DSA and DJAN

10G-KR 10GBASE-KR/KR4 Compliance and Debug Solution 40G-CR4 40GBASE-CR4 Debug and Automated Compliance Solution

Other upgrades for MSO/ DPO70000 Series

> Additional Windows 10 SSD drive. For units shipped with Windows 10, or to upgrade from Windows 7 to Windows 10. Microsoft DPO7SSD-W10

Windows 10 OS, TekScope, and applications software installed.

Note: Order DPO7SSD-W10, do not order DPO-UP for this SSD.

As signals get faster and new standards are developed, your investment in an MSO/DPO70000 Series instrument can evolve with Investment protection options

your needs. You can upgrade the bandwidth of the unit you own today. You can take advantage of MSO/DPO70000 series performance improvements by upgrading your existing unit to a new series, or adding MSO features to your current DPO model. Contact your local Tektronix representative to discuss the full range of options available to ensure your MSO/DPO70000 series

oscilloscope has the tools you need for your next project.

Language options

Opt. L0 English manual Opt. L1 French manual Opt. L3 German manual Opt. L5 Japanese manual

Opt. L7 Simplified Chinese manual Opt. L8 Traditional Chinese manual

Opt. L9 Korean manual Opt. L10 Russian manual No manual Opt. L99

Power plug options

Opt. A0 North America power plug (115 V, 60 Hz) Opt. A1 Universal Euro power plug (220 V, 50 Hz) Opt. A2 United Kingdom power plug (240 V, 50 Hz) Opt. A3 Australia power plug (240 V, 50 Hz) Opt. A5 Switzerland power plug (220 V, 50 Hz) Japan power plug (100 V, 50/60 Hz) Opt. A6

Opt. A10 China power plug (50 Hz) Opt. A11 India power plug (50 Hz) Opt. A12 Brazil power plug (60 Hz)

Opt. A99 No power cord

Service options

Opt. C3 Calibration Service 3 Years Opt. C5 Calibration Service 5 Years Opt. D1 Calibration Data Report

Opt. D3 Calibration Data Report 3 Years (with Opt. C3) Opt. D5 Calibration Data Report 5 Years (with Opt. C5)

Opt. G3 Complete Care 3 Years (includes loaner, scheduled calibration, and more) Opt. G5 Complete Care 5 Years (includes loaner, scheduled calibration, and more)

Opt. IF Upgrade Installation Service

Opt. R3 Repair Service 3 Years (including warranty) Opt. R5 Repair Service 5 Years (including warranty)

Recommended accessories

Probes

DPO70E1 33 GHz optical probe DPO70E2 59 GHz optical probe

P7633 33 GHz Low Noise TriMode™ Probe P7630 30 GHz Low Noise TriMode™ Probe 25 GHz Low Noise TriMode™ Probe P7625

P7720 20 GHz TriMode Probe P7716 16 GHz TriMode Probe P7713 13 GHz TriMode Probe P7708 8 GHz TriMode Probe P7520A 25 GHz TriMode™ probe P7516 16 GHz TriMode™ probe

P7513A 13 GHz TriMode[™] differential probe P7313SMA 13 GHz TriMode™ differential SMA probe

P7508 8 GHz TriMode[™] probe P7506 6 GHz TriMode[™] probe P7504 4 GHz TriMode[™] probe P6780 Differential Input Logic probe P6750 D-Max® Technology Logic Probe P6717A General-purpose Logic probe

P6251 DC to 1 GHz, 42 V, differential probe (requires TCA-BNC adapter)

TCPA300/TCPA400 Series Current measurement systems P5200A/P5205A/P5210A High-voltage differential probes

P77DESKEW P7700 Probe Deskew Fixture for SMA, solder-down, and browser connections 067-2431-xx Probe Deskew Fixture for SMA or solder-down connections (up to 30 GHz)

067-0484-xx Analog Probe Calibration and Deskew Fixture (4 GHz)

067-1586-xx Analog Probe Deskew Fixture (>4 GHz)

067-1686-xx Power Deskew Fixture

Adapters

TCA-1MEG TekConnect® high-impedance buffer amplifier. Includes P6139B passive probe

TCA-292MM TekConnect® to 2.92 mm adapter (20 GHz bandwidth) **TCA-292D** TekConnect® to 2.92 mm adapter (33 GHz bandwidth)

TCA-BNC TekConnect® to BNC adapter TCA-N TekConnect® to N adapter TCA-SMA TekConnect® to SMA adapter TCA-VPI50 50 Ω TekVPI to TekConnect adapter

23 GHz precision TekConnect® 75 Ω to 50 Ω adapter with 75 Ω BNC input connector TCA75

Cables

Multi-scope synchronization kit (includes fast edge source, cables, power splitters, carrying case) **DPOACQSYNC**

012-0991-xx GPIB Cable (1 m) 012-0991-xx GPIB Cable (2 m)

Datasheet

P6780 Logic Probe standard accessories

067-2298-xx Deskew Fixture, logic probes

 020-3035-xx
 Standard adapter

 020-3036-xx
 Wide Body adapter

 020-3032-00
 25°/55° holder

 020-3021-00
 Heat Strip wire (4.57 m)

 020-3031-xx
 Hand Browsing adapter

020-3033-xx Flex adapter 020-3038-xx Lead set ground

020-3042-xx Probe grouper (including header pins)

020-3034-xx Ferrite beads **020-3037-xx** Wire tubing (4.57 m)

P6717A Logic Probe standard

accessories

HEX-P6960PIN D-MAX Probe footprint to square pin header

NEX-HD2HEADER⁴ Mictor to square pin header adapter
067-2298-xx Deskew Fixture, logic probes

206-0559-xx Extension ground tip

 131-5638-xx
 Probe tip

 206-0569-xx
 IC grabber

 352-1115-xx
 Probe grouper

 196-3501-xx
 Lead sets

 196-3497-xx
 Ground lead sets

Memory testing

NEX-DDR3MP78BSC DDR3 ×4/×8 Solder Chip Interposer NEX-DDR3MP78BSCSK DDR3 ×4/×8 Socket Chip Interposer **NEX-DDR3MP96BSC** DDR3 ×16 Solder Chip Interposer NEX-DDR3MP96BSCSK DDR3 ×16 Socket Chip Interposer NEX-DDR2MP60BSC DDR2 ×4/×8 Solder Chip Interposer NEX-DDR2MP60BSCSK DDR2 ×4/×8 Socket Chip Interposer NEX-DDR2MP84BSC DDR2 ×16 Solder Chip Interposer NEX-DDR2MP84BSCSK DDR2 ×16 Socket Chip Interposer

Instrumented DIMM for DDR3 4 Order Scope NEXVu card for UDIMM Raw Card E. (Contact http://www.nexustechnology.com)

System Test

TDSUSBF Test Fixture for use with Opt. USB

TF-XGbT⁴ 10GBASE-T Fixture for use with Option XGbT Software

Ethernet Test Fixture. Order through Crescent Heart Software (http://www.c-h-s.com)

TF-HEAC-TPA-KIT HEAC TPA-KIT consists of: Main Board; Plug A-type board; Plug C-type board; 2 × TDR board with A Receptacle; 2 × TDR board

with C Receptacle

TF-HDMI-TPA-S/STX HDMI Type C fixture set for Tx/Rx

TF-HDMIC-TPA-S/STX TF-HDMIC-TPA-S/STX
TF-HDMIE-TPA-KIT HDMI Type E Fixture set

⁴ Notice to EU customers: This product is not updated to comply with the RoHS 2 Directive 2011/65/EU and will not be shipped to the EU. Customers may be able to purchase products from inventory that were placed on the EU market prior to July 22, 2017 until supplies are depleted. Tektronix is committed to helping you with your solution needs. Please contact your local sales representative for further assistance or to determine if alternative product(s) are available. Tektronix will continue service to the end of worldwide support life.

Digital and Mixed Signal Oscilloscopes - MSO/DPO70000 Series

HDMI Type D Fixtures TF-HDMID-TPA-P/R TF-MHL-TPA-TEK MHL Fixture set

S46-6666-A-AMER Keithley Instruments RF/Microwave switch system, 32 channel, unterminated, Americas power cord S46-6666-A-ASIAP Keithley Instruments RF/Microwave switch system, 32 channel, unterminated, Asia-Pacific power cord S46-6666-A-EURAF Keithley Instruments RF/Microwave switch system, 32 channel, unterminated, Europe/Africa power cords

TF-USB3-AB-KIT 5 USB 3.0 A/B Fixture/Cable Kit

TF-USB3-A-P USB 3.0 A Plug Fixture

TF-USB3-A-R5 USB 3.0 A Receptacle Fixture Kit TF-USB3-B-R USB 3.0 B Receptacle Fixture Kit

TF-GBE-ATP 10/100/1000BASE-T Advanced Test Package (consists of test fixture PCB set, RJ45 interconnect cable, and 1000BASE-T jitter

test channel cable)

TF-GBE-BTP 10/100/1000BASE-T Basic Test Package (consists of test fixture PCB set and RJ45 interconnect cable)

TF-GBE-JTC 103 meter 1000BASE-T jitter test channel cable **TF-GBE-SIC** Short (4 inch (0.1 meter)) RJ45 interconnect cable

TF-XGbT 5 Test fixtures that complement the use of the TekEXP-XGbT solution



Transit Case (carbon fiber).

Other

016-1985-xx Rackmount Kit

077-0076-xx Service Manual, pdf on hard drive

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Datasheet

016-2039-00 Transit Case (metal frame, wood panels)

016-2043-00 Transit Case (carbon fiber)

TF-TEKPROTECT ESD Protection Tester:

MSO/DPO70000C instruments include TekProtect circuitry designed to stop EOS/ESD events from reaching analog channel preamp inputs, while still allowing normal signals to pass. TekProtect should be checked regularly with the TF-TEKPROTECT ESD

Protection Tester to ensure the device is still working.

Warranty

One-year warranty covering all parts and labor.





Tektronix is registered to ISO 9001 and ISO 14001 by SRI Quality System Registrar.



Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.

ASEAN / Australasia (65) 6356 3900 Belgium 03800 2255 4835* Central East Europe and the Baltics +41 52 675 3777 Finland +41 52 675 3777 Hong Kong 400 820 5835 Japan 81 (3) 6714 3086 Middle East, Asia, and North Africa +41 52 675 3777 People's Republic of China 400 820 5835 Republic of Korea +822 6917 5084, 822 6917 5080 Spain 00800 2255 4835* Taiwan 886 (2) 2656 6688 Austria 00800 2255 4835*
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Central Europe & Greece +41 52 675 3777
France 00800 2255 4835*
India 000 800 650 1835
Luxembourg +41 52 675 3777
The Netherlands 00800 2255 4835*
Poland +41 52 675 3777
Russia & CIS +7 (495) 6647564
Sweden 00800 2255 4835*
United Kingdom & Ireland 00800 2255 4835*

Balkans, Israel, South Africa and other ISE Countries +41 52 675 3777 Canada 1 800 833 9200

Canada 1 800 833 9200 Denmark +45 80 88 1401 Germany 00800 2255 4835* Italy 00800 2255 4835*

Mexico, Central/South America & Caribbean 52 (55) 56 04 50 90

Norway 800 16098 Portugal 80 08 12370 South Africa +41 52 675 3777 Switzerland 00800 2255 4835* USA 1 800 833 9200

For Further Information. Tektronix maintains a comprehensive, constantly expanding collection of application notes, technical briefs and other resources to help engineers working on the cutting edge of technology. Please visit www.tek.com.

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 $^{^{\}star}$ European toll-free number. If not accessible, call: +41 52 675 3777